



Data Collection and Reduction with APEX6

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Ashley (Weiland) Schmidt – Applications Scientist SC-XRD



Awards

- ACS Division of Inorganic Chemistry Young Investigator Awardee
- Eugene McDermott Graduate Fellow
- DOE Office of Science Graduate Student Research Awardee
- Excellence in Education Foundation Scholar
- Duquesne University Bayer Scholar

Experience

- Bruker Applications Scientist (Nov '21)
- Director's Postdoctoral Fellow – Los Alamos National Laboratory
 - Mapped crystallographic deviations in samples of unconventional superconductor, UTe₂, exhibiting varying superconducting transition temperatures

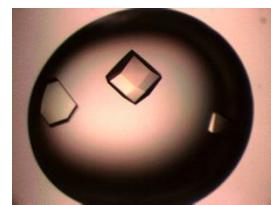
Education

- PhD Chemistry (Advisor: Dr. Julia Chan)
 - Elucidated complex crystal structures of intermetallics
- SCGSR Awardee (Argonne National Laboratory - Advisor: Dr. Saul Lapidus)
 - Designed and built experimental setups for high temperature *in situ* synchrotron powder X-ray diffraction characterization
- B.S. Environmental Chemistry (Research Advisor: Dr. Jen Aitken)
 - Synthesis and characterization of Li₂-II-IV-S₄ semiconductors

Publications

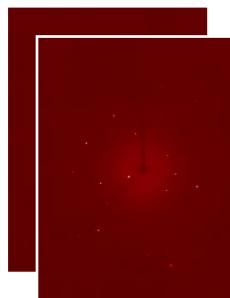
- 20+ publications in peer reviewed scientific journals, over 500 citations

SCD Workflow



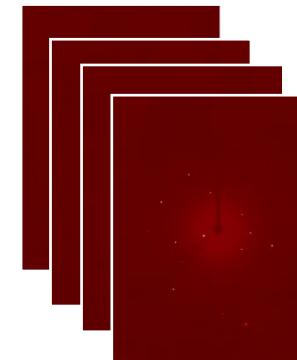
Sample

Screening/
Indexing

Diffraction
Frames

5 – 15 GB

Data
Collection

Full set of Diffraction
Frames

Data
Reduction

1	0	0	1.0000	0.3000
1	0	0	1.1000	0.2000
-1	0	0	2.1000	0.5000
2	0	0	4919.51	199.78
-2	0	0	4931.71	191.98
3	0	0	0.1000	0.3000
3	0	0	0.3000	0.3000
-3	0	0	1.2000	0.3000
4	0	0	837.52	21.50
-4	0	0	856.61	16.60
5	0	0	1.3000	
6	0	0	1230.28	32.20
7	0	0	-0.4000	1.5000
0	-1	0	0.2000	0.1000
0	-1	0	0.4000	0.1000
0	-1	0	0.3000	0.1000
1	1	0	170.48	4.40
1	-1	0	161.58	4.70
-1	-1	0	170.28	4.40
-1	-1	0	175.58	4.10
1	-1	0	178.88	4.50
1	-1	0	171.38	4.40
1	1	0	170.58	4.10

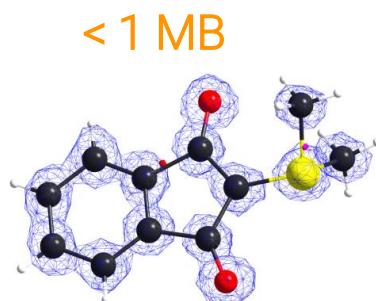
HKL Intensity
Data

5 – 50 MB



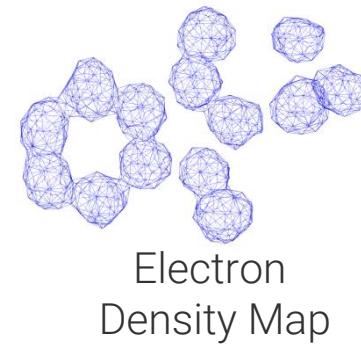
Publication

Validation



Atomic Model

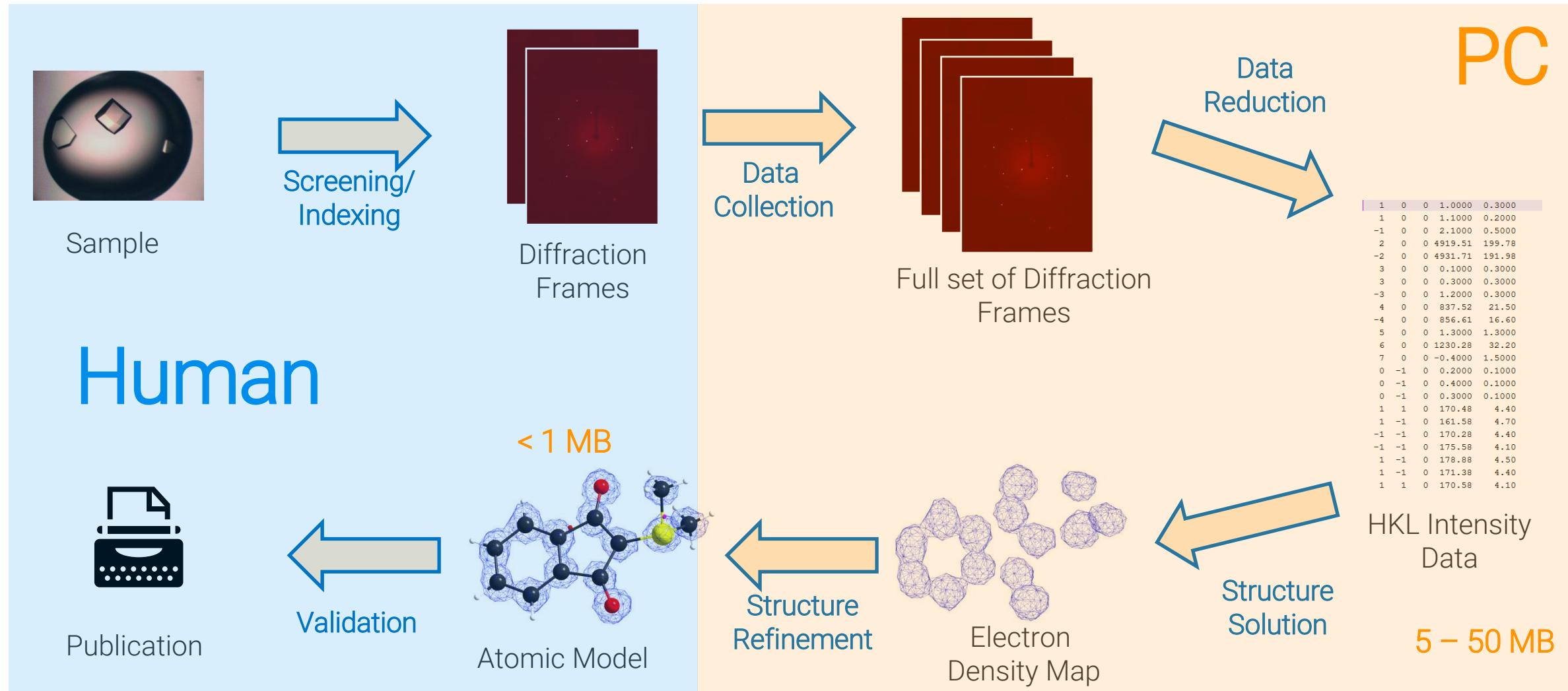
Structure
Refinement

Electron
Density Map

Structure
Solution

Data
Reduction

SCD Workflow



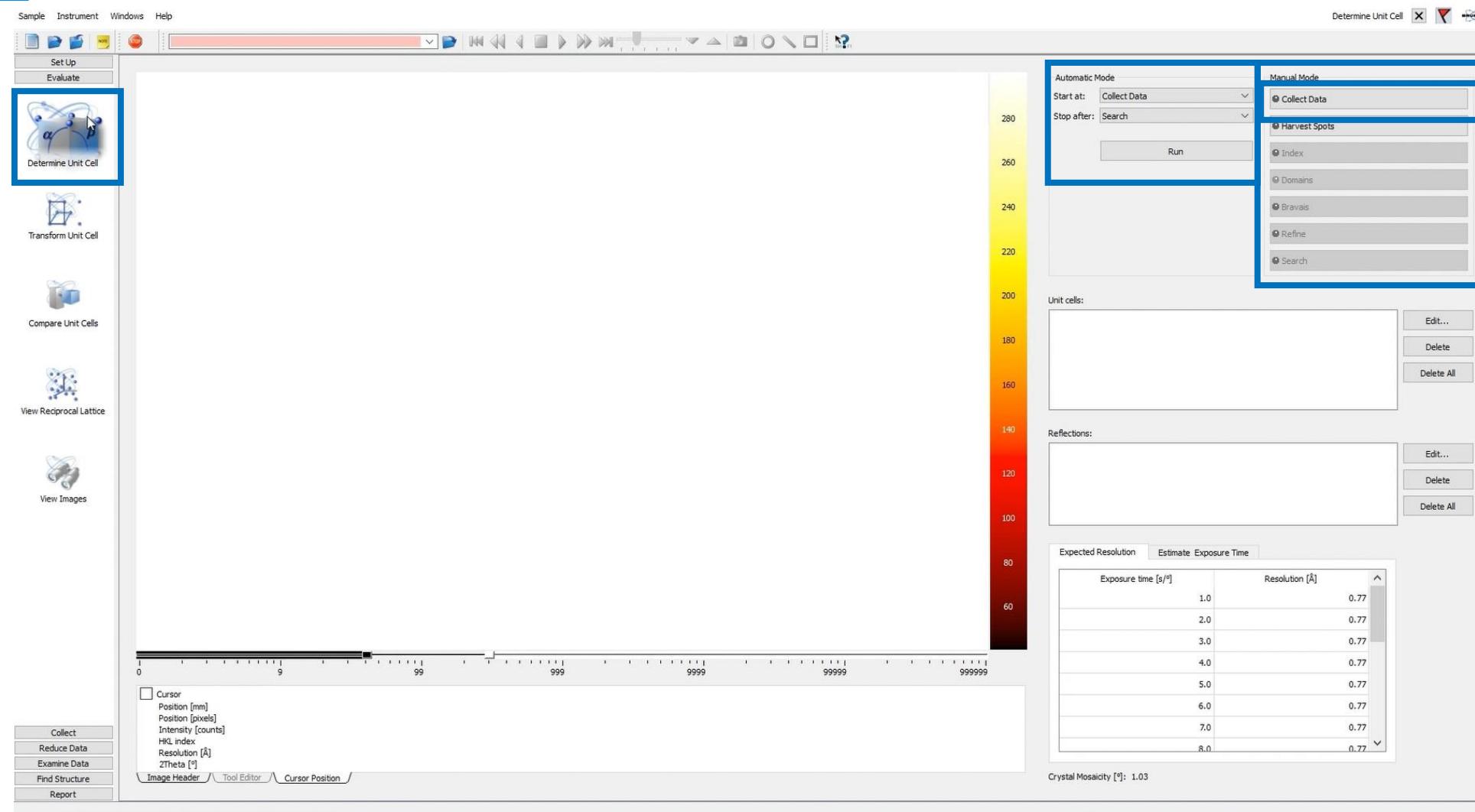


DATA COLLECTION AND REDUCTION WITH APEX6

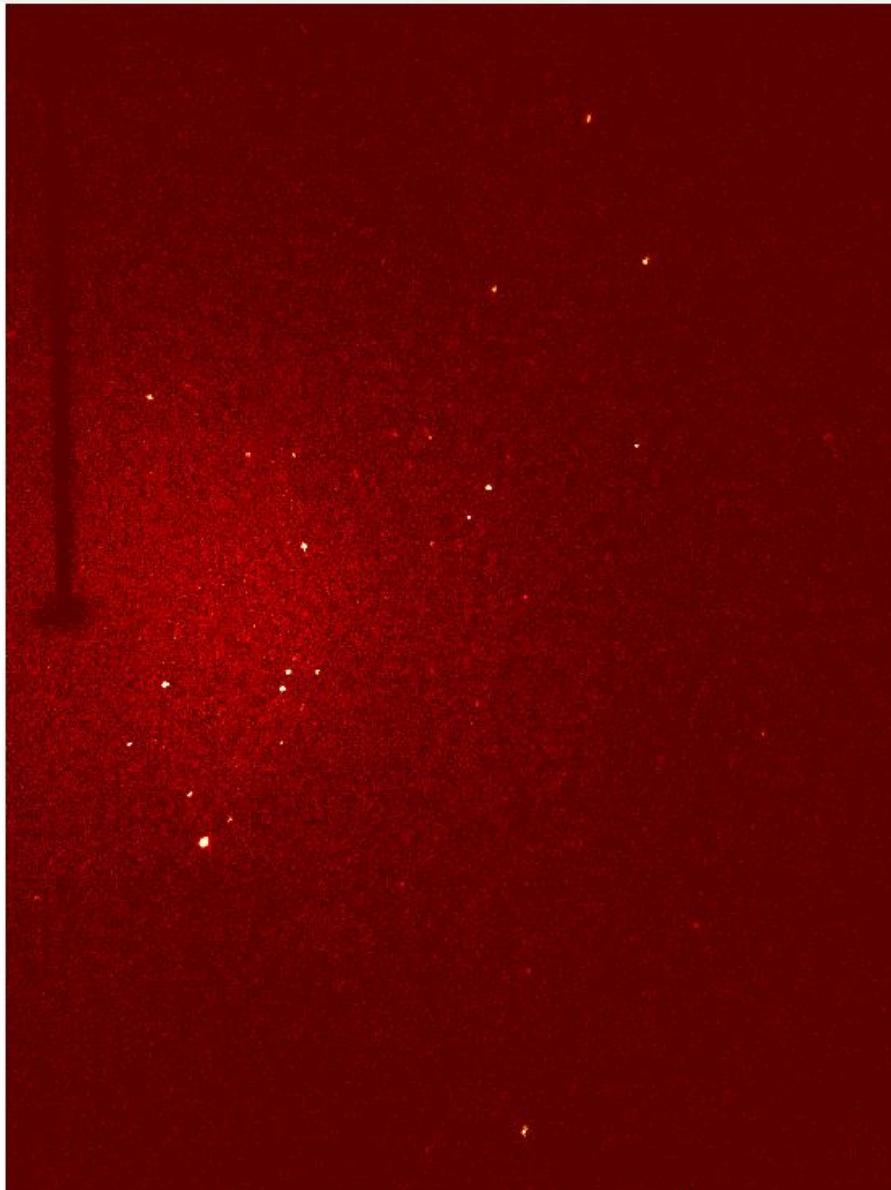
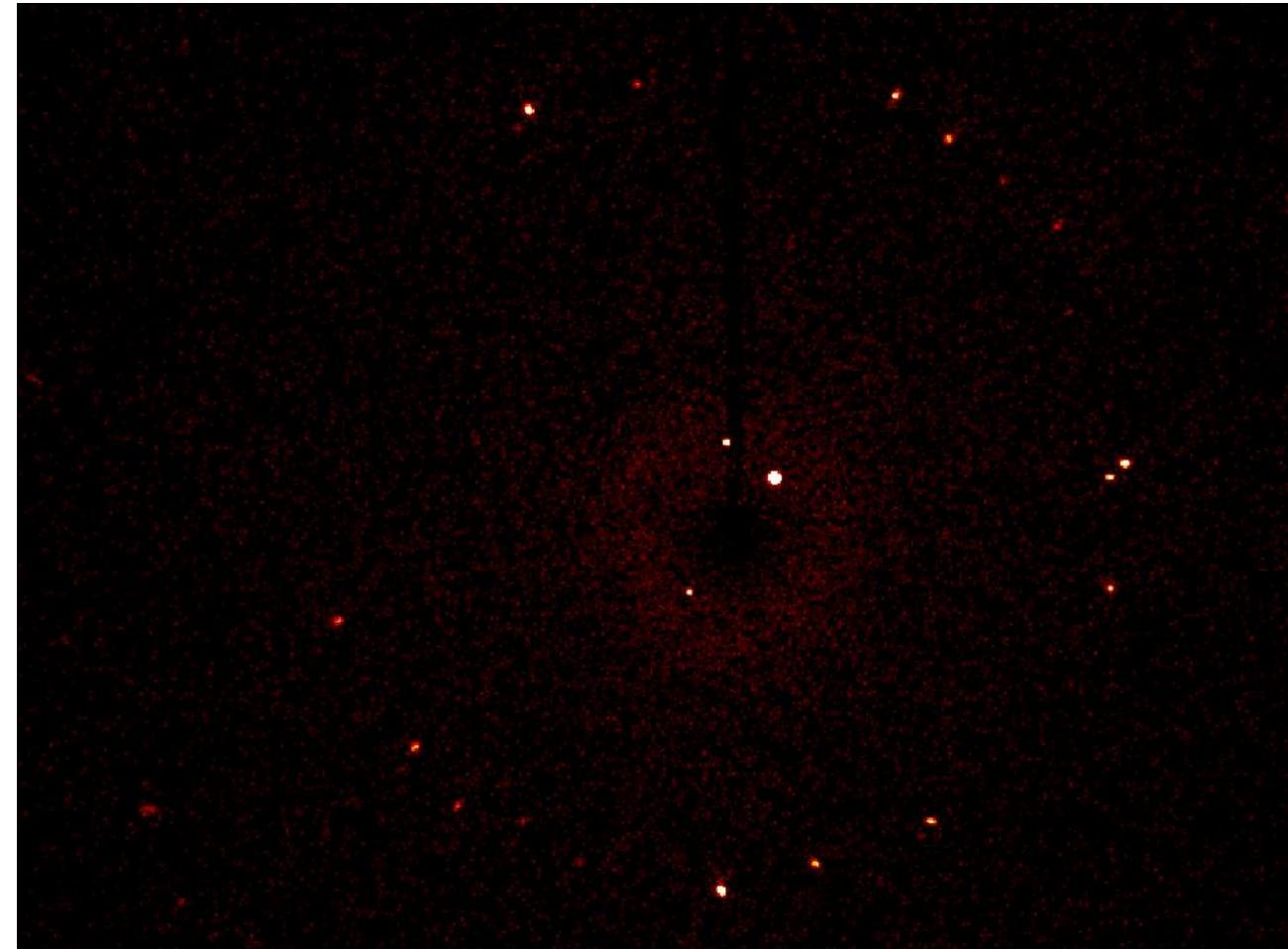
Unit Cell Determination in APEX6

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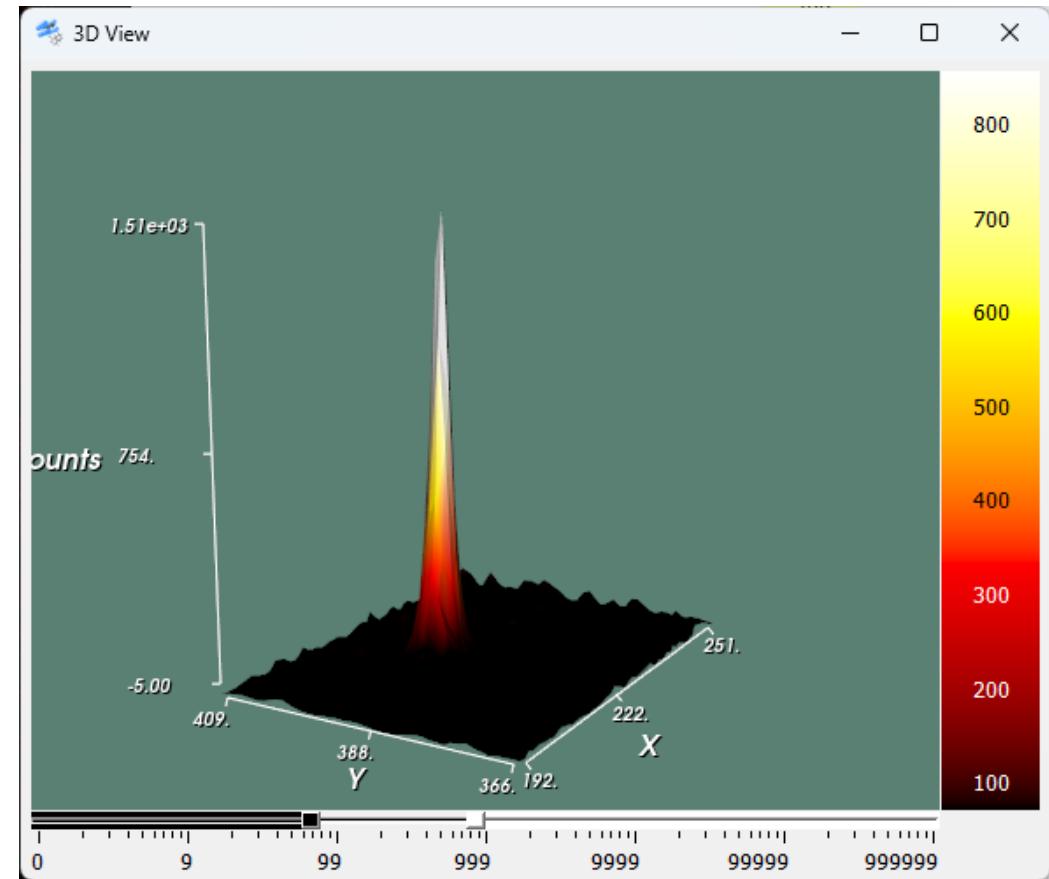
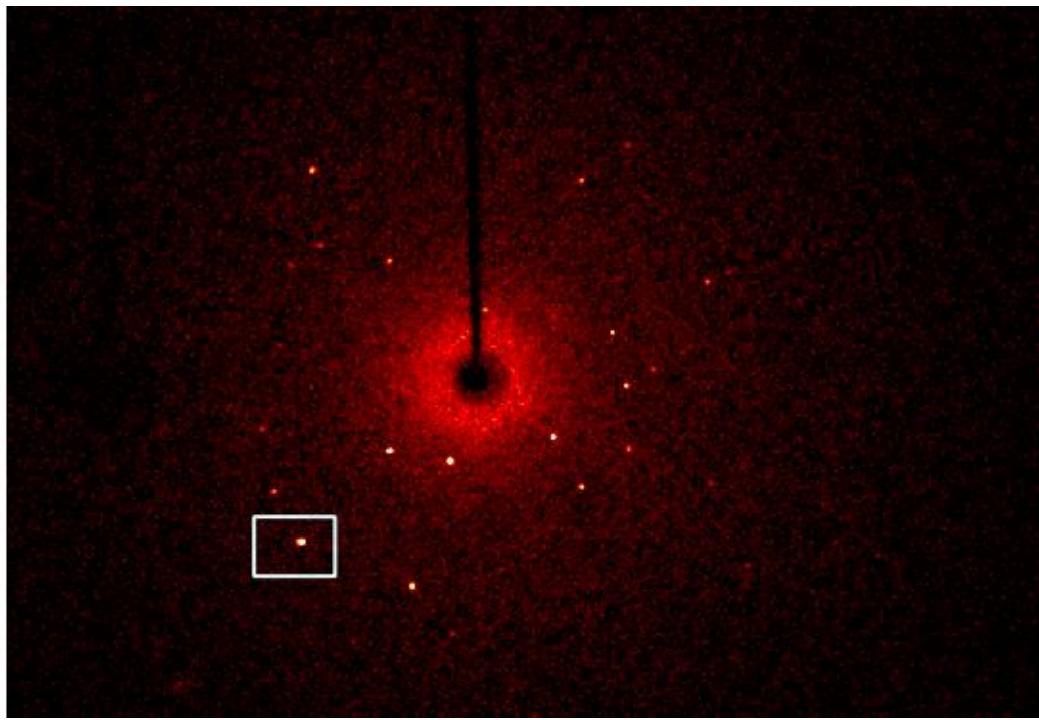
Determine Unit Cell – Collect Data



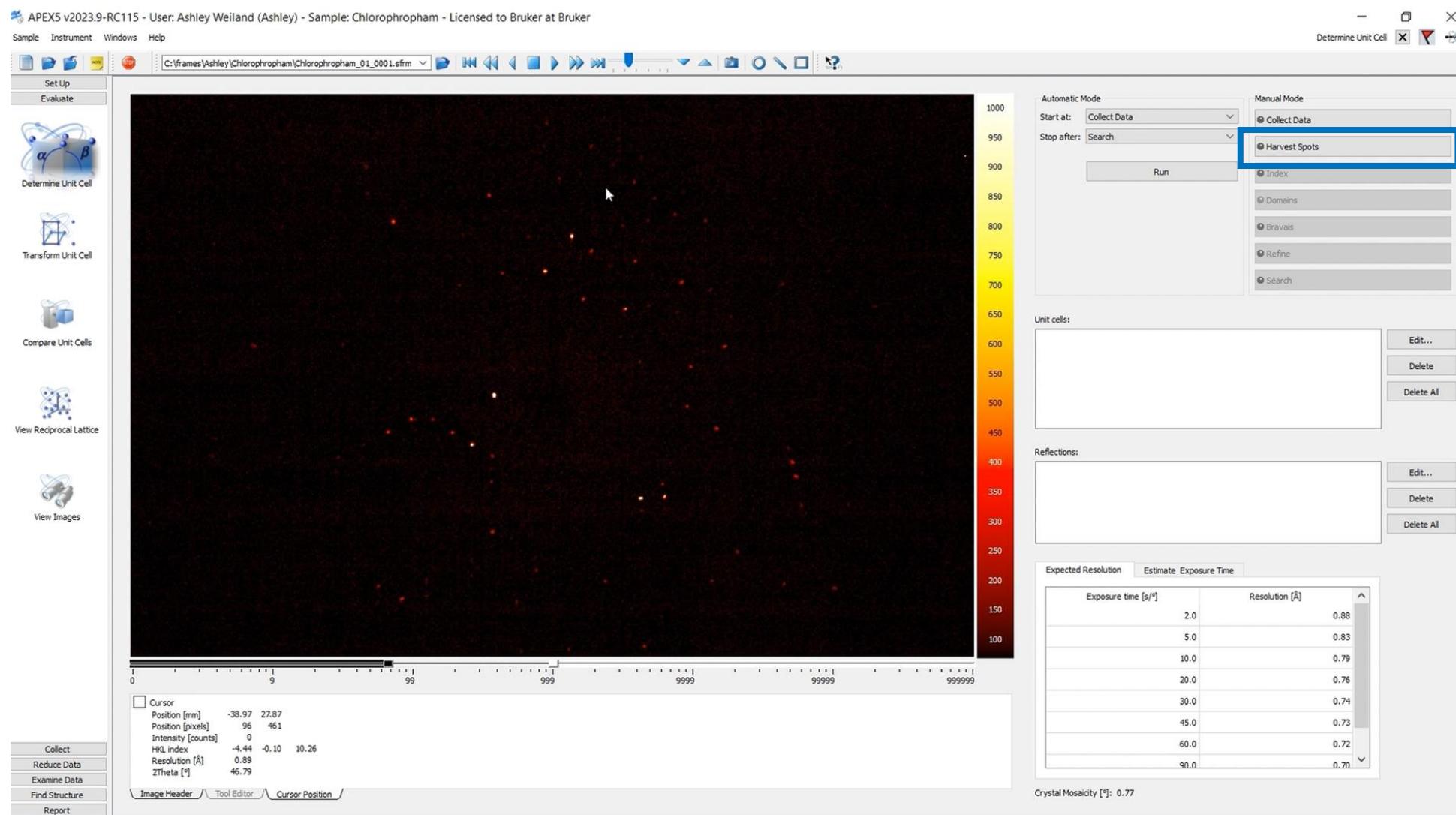
What Do Data Frames Look Like?



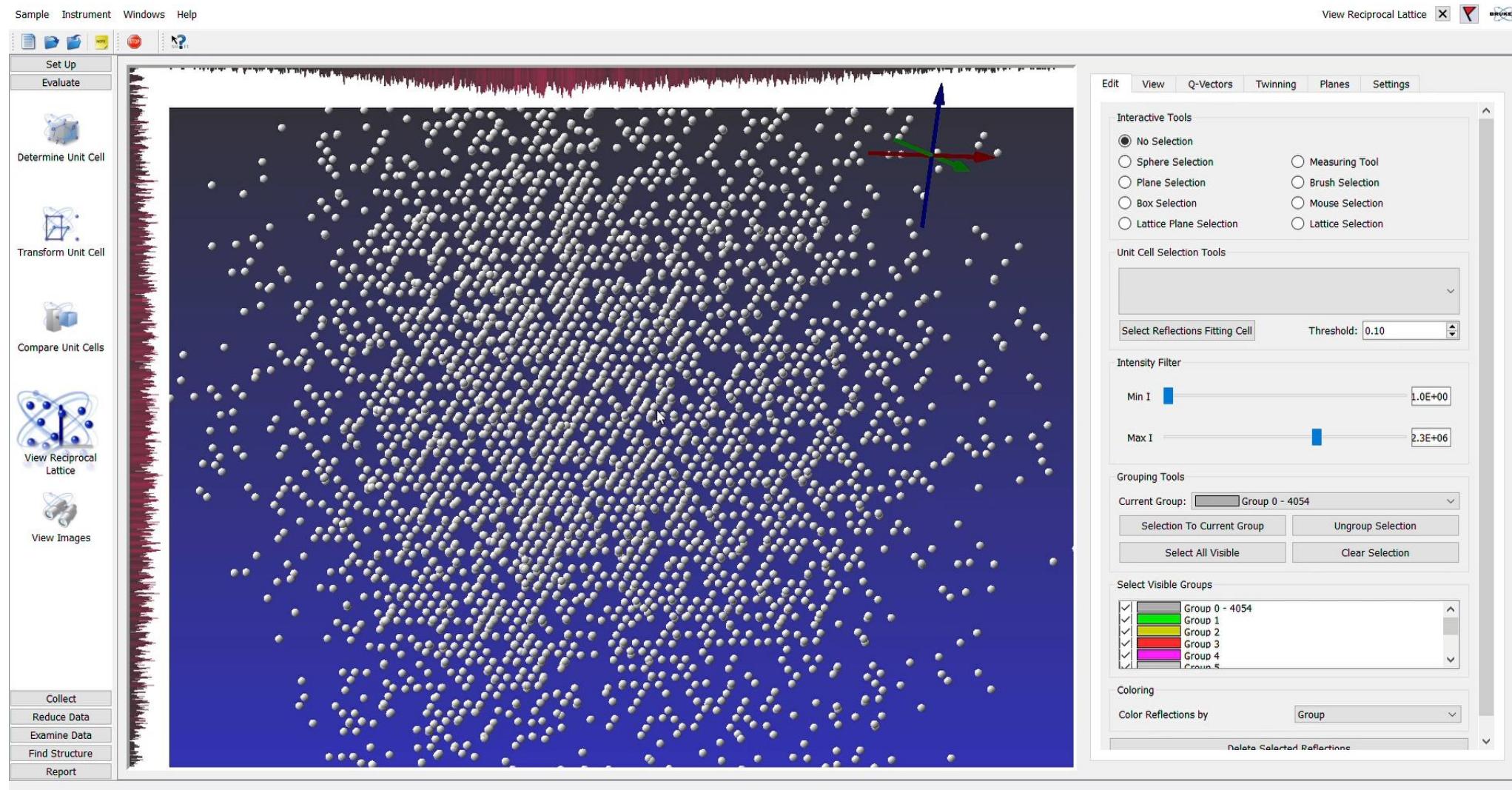
3D View of a Reflection



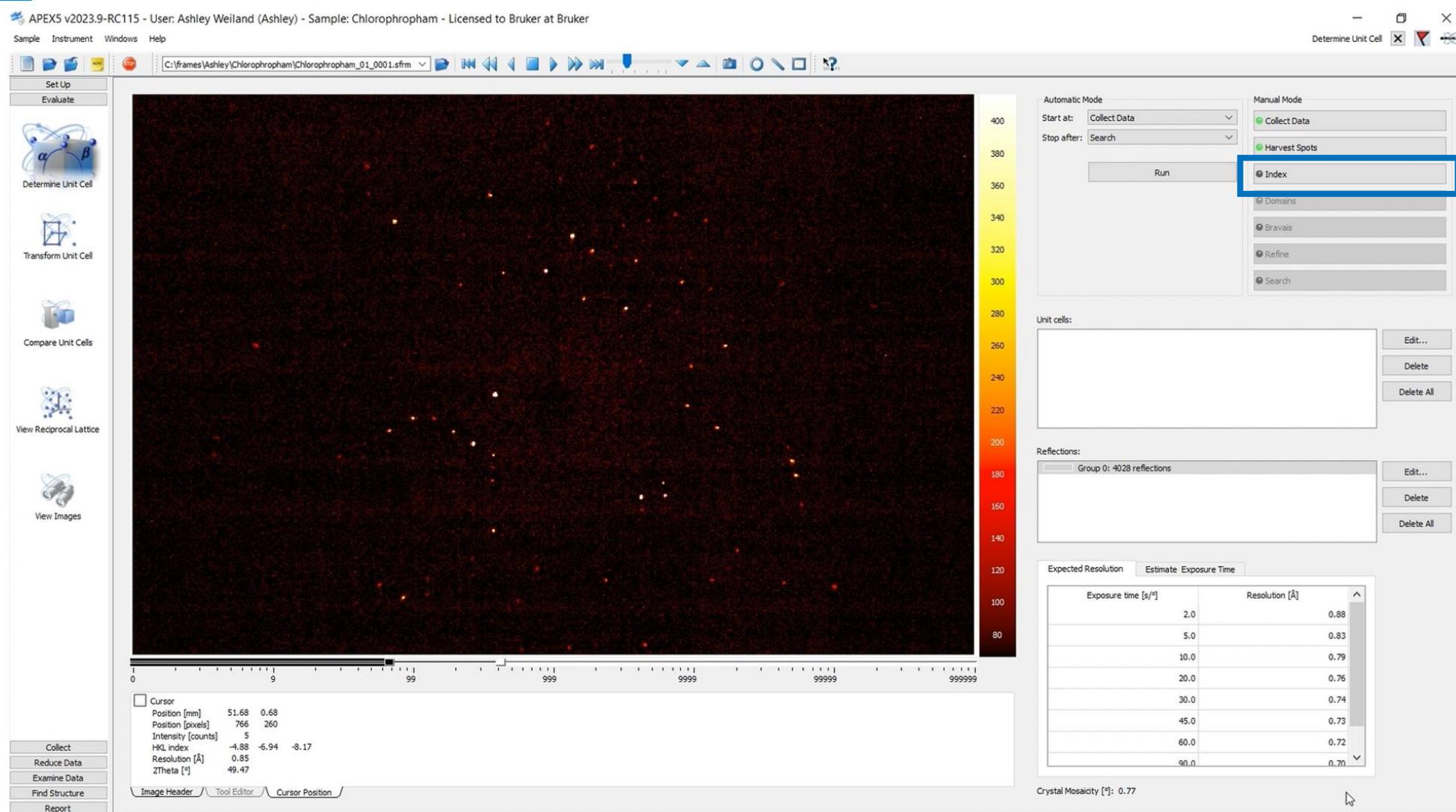
Determine Unit Cell – Harvest Spots



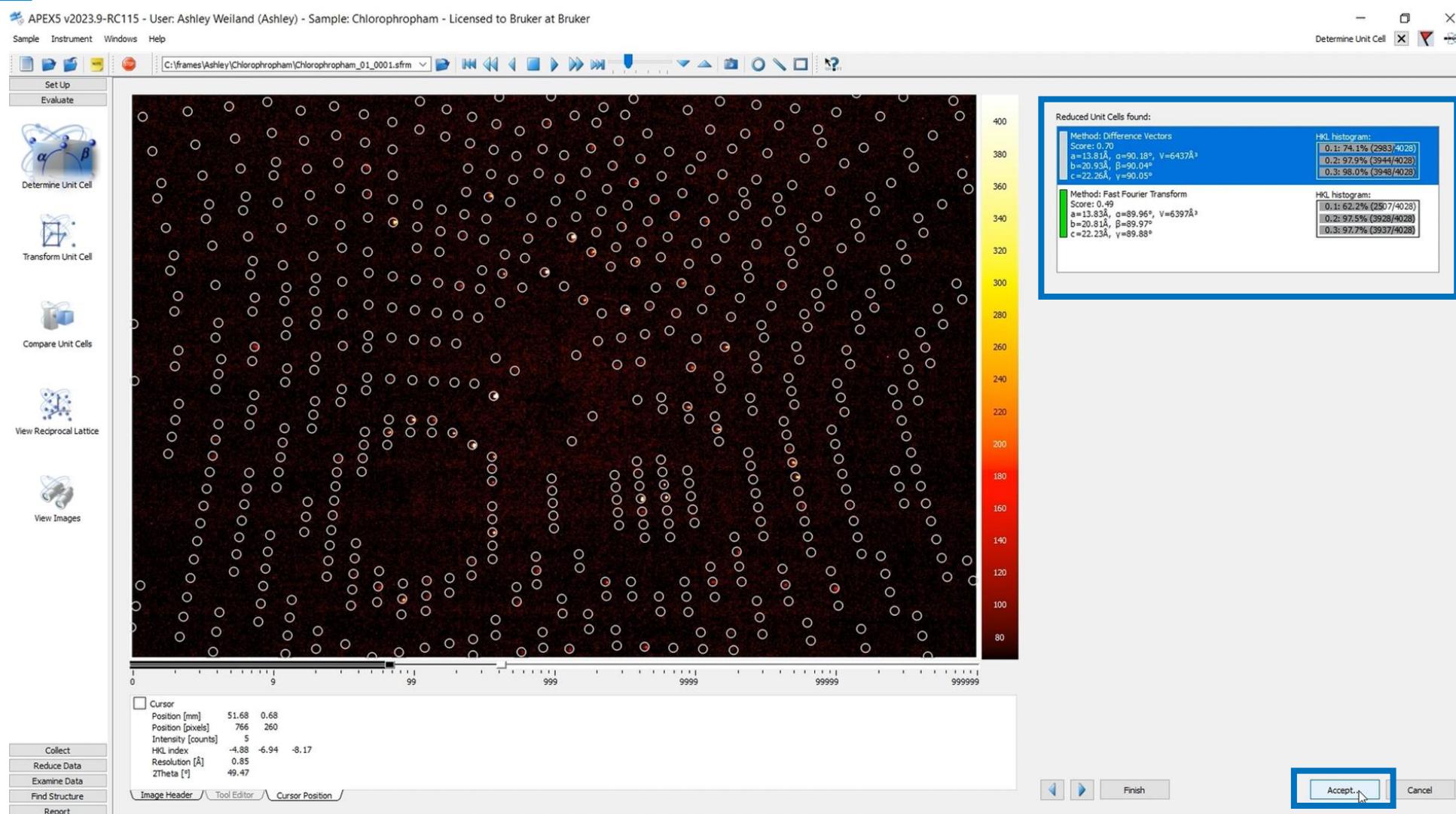
Seeing Symmetry (video)



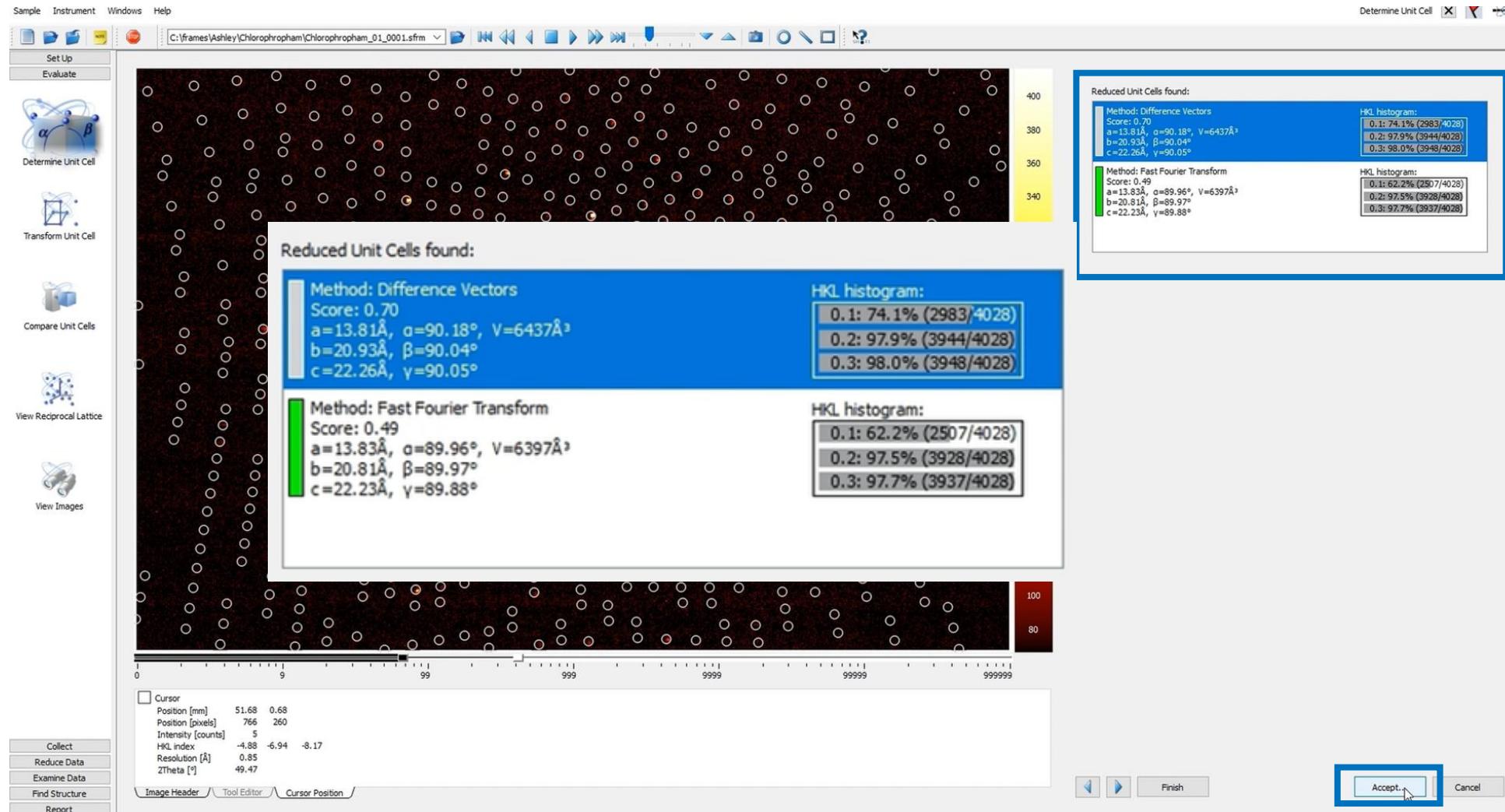
Determine Unit Cell – Index



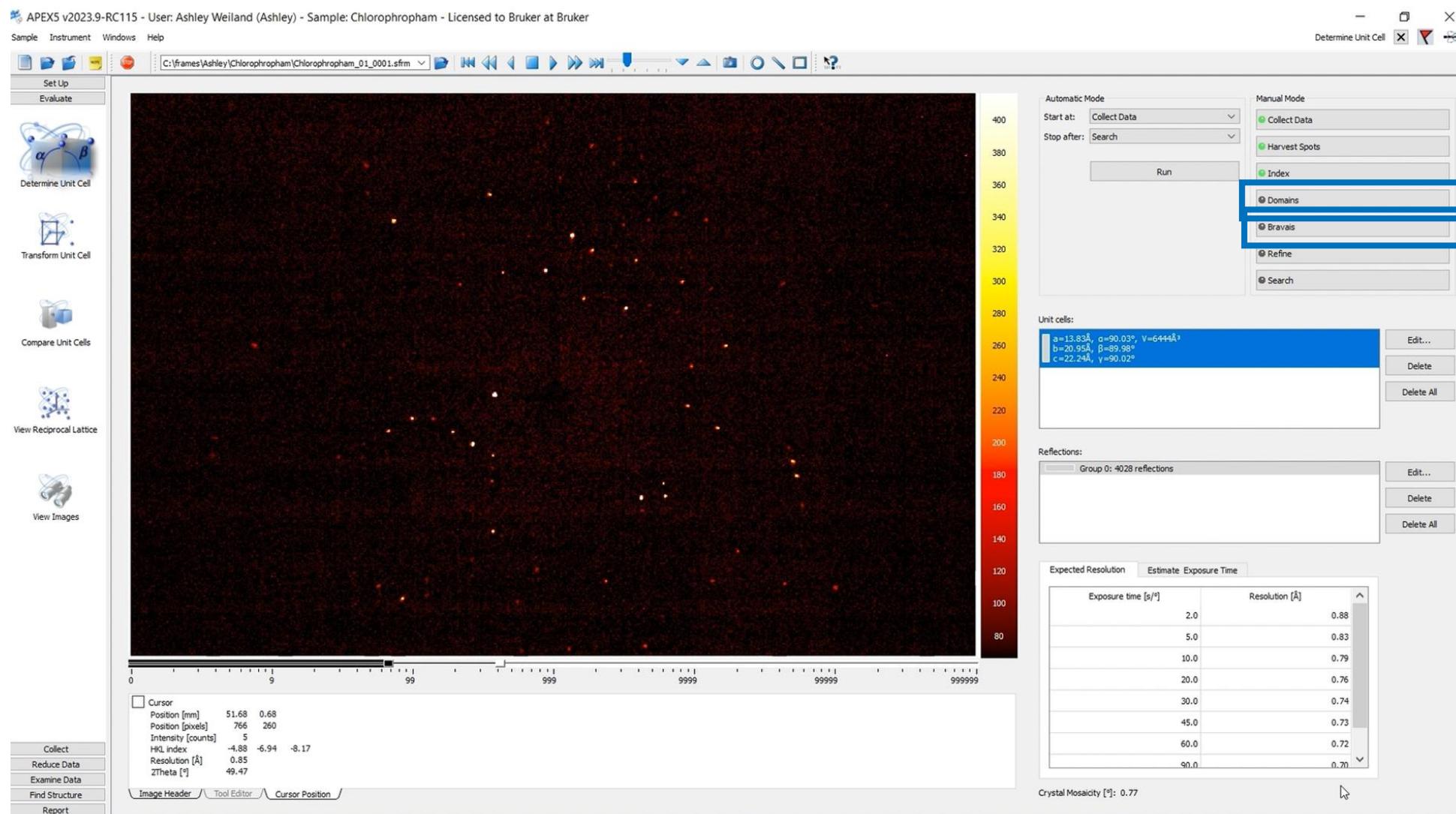
Determine Unit Cell – Index



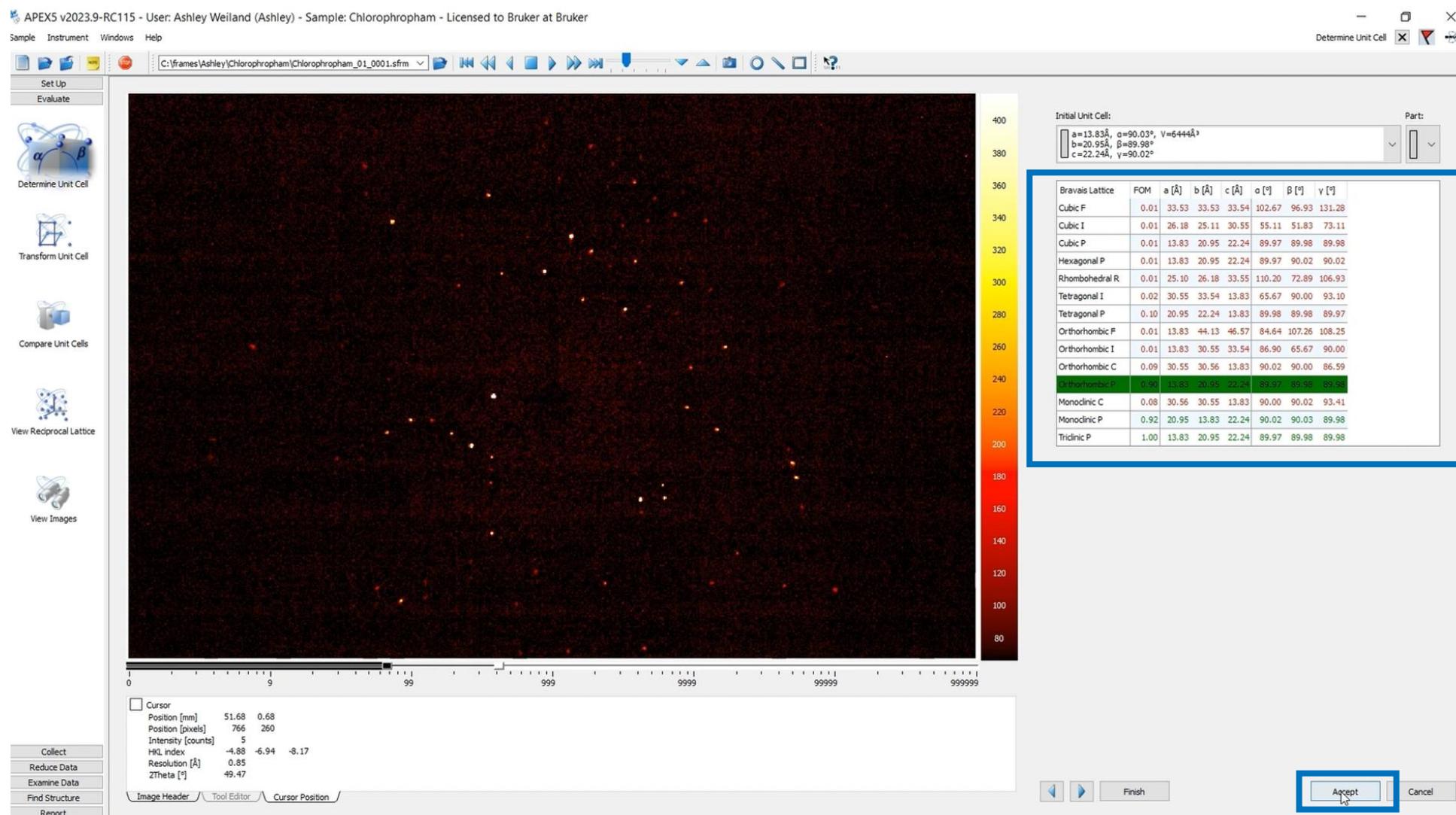
Determine Unit Cell – Index



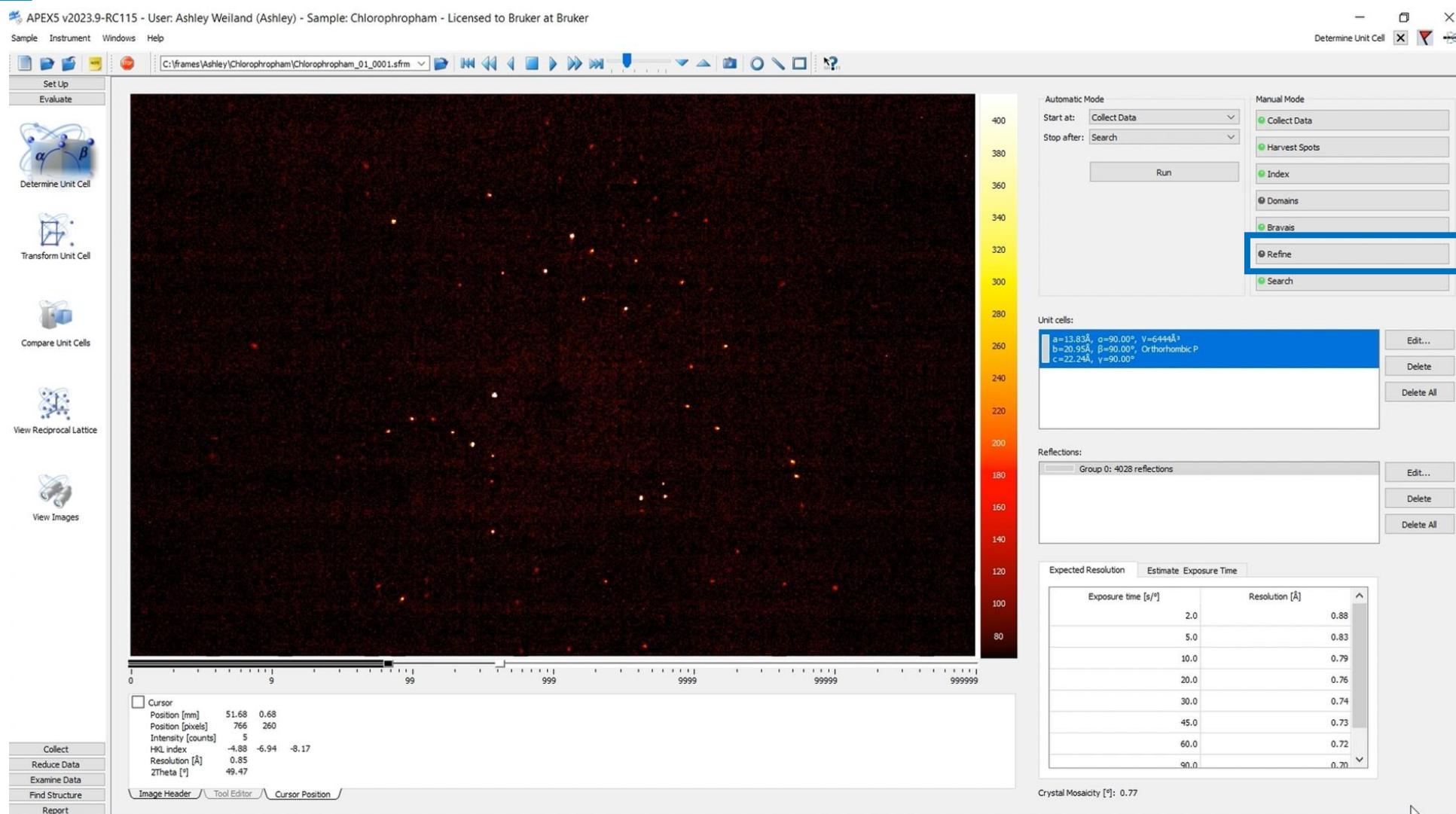
Determine Unit Cell – Bravais



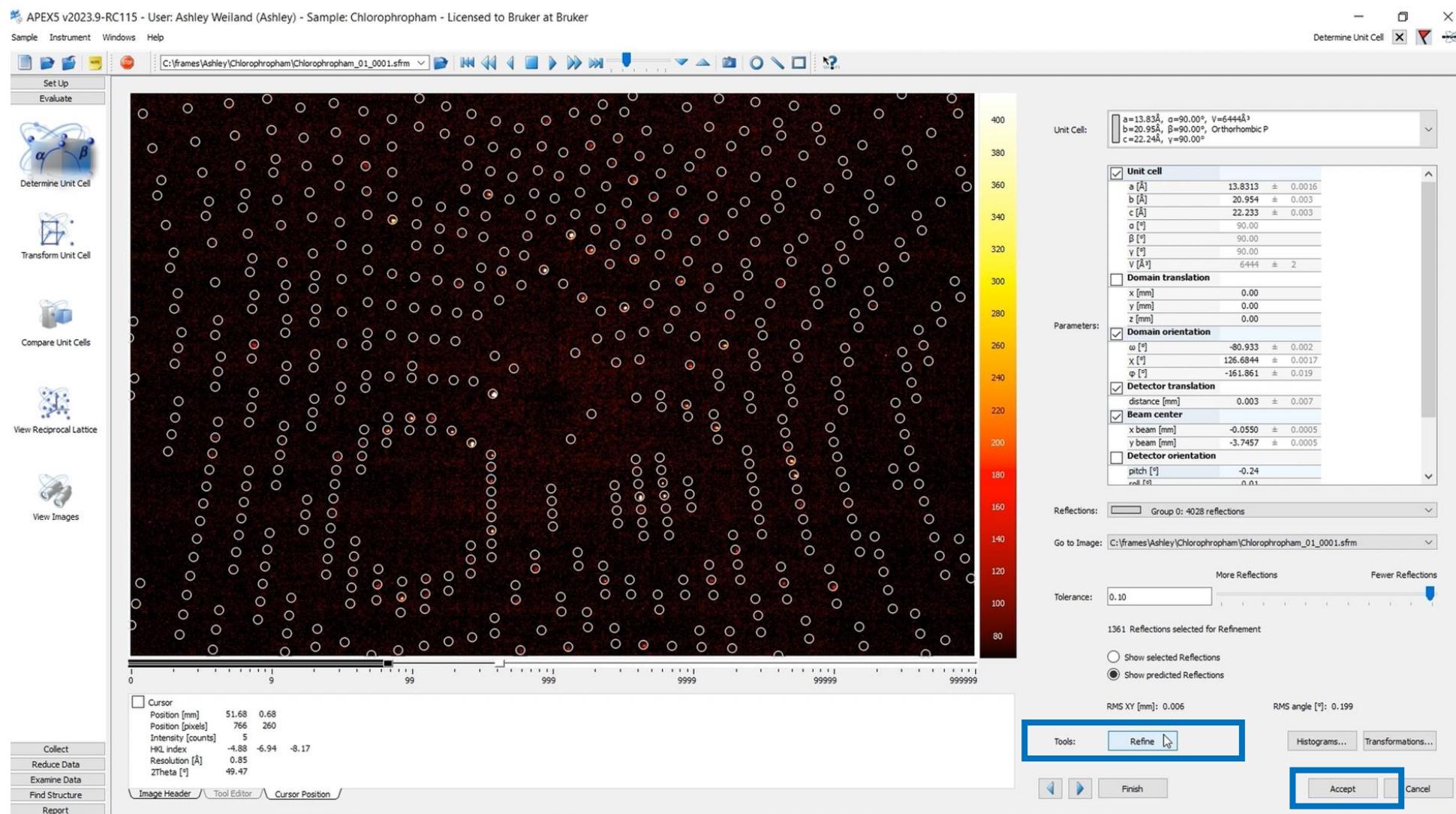
Determine Unit Cell – Bravais



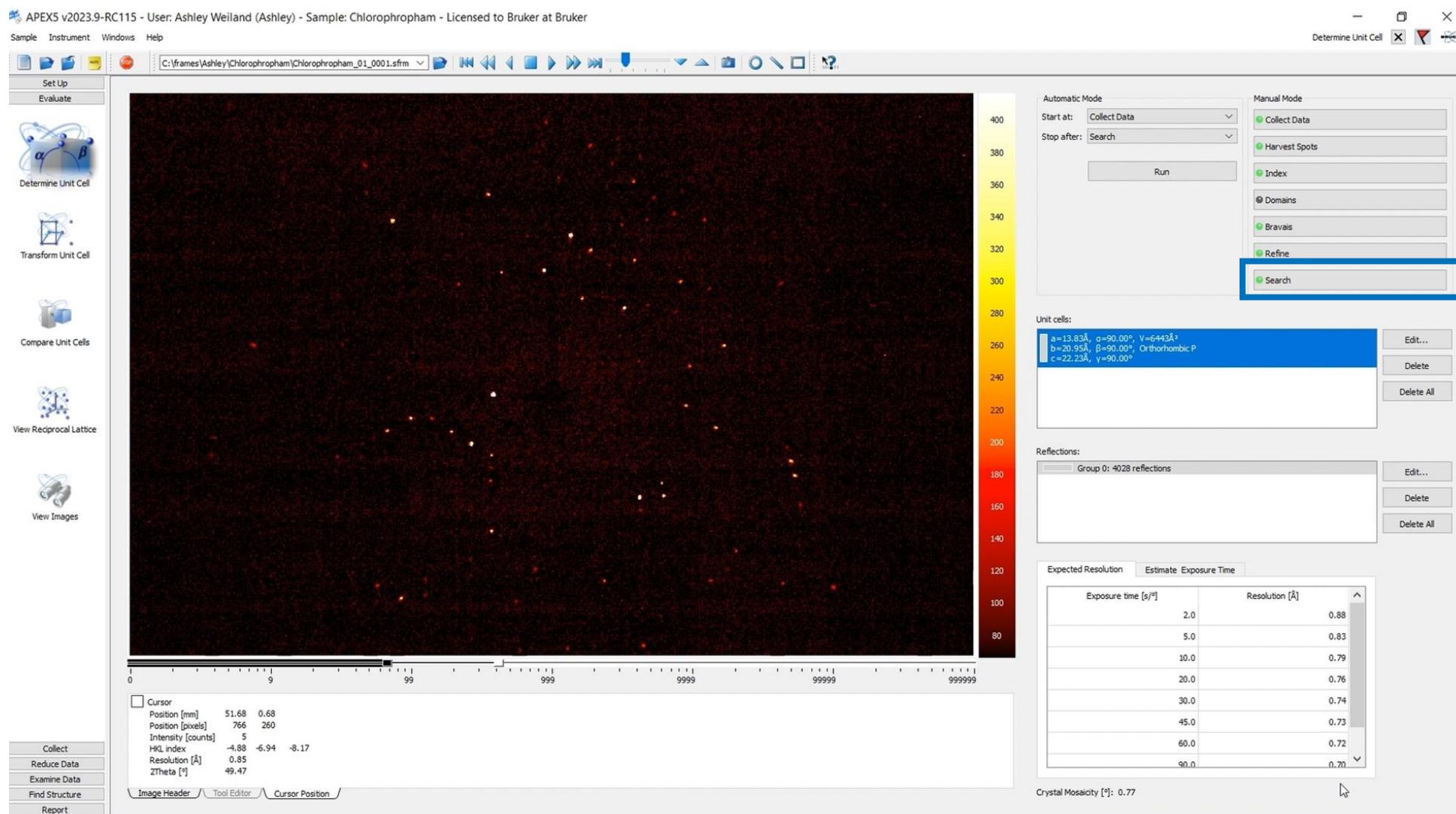
Determine Unit Cell – Refine



Determine Unit Cell – Refine



Determine Unit Cell – Search





DATA COLLECTION AND REDUCTION WITH APEX6

Strategy Determination in APEX6

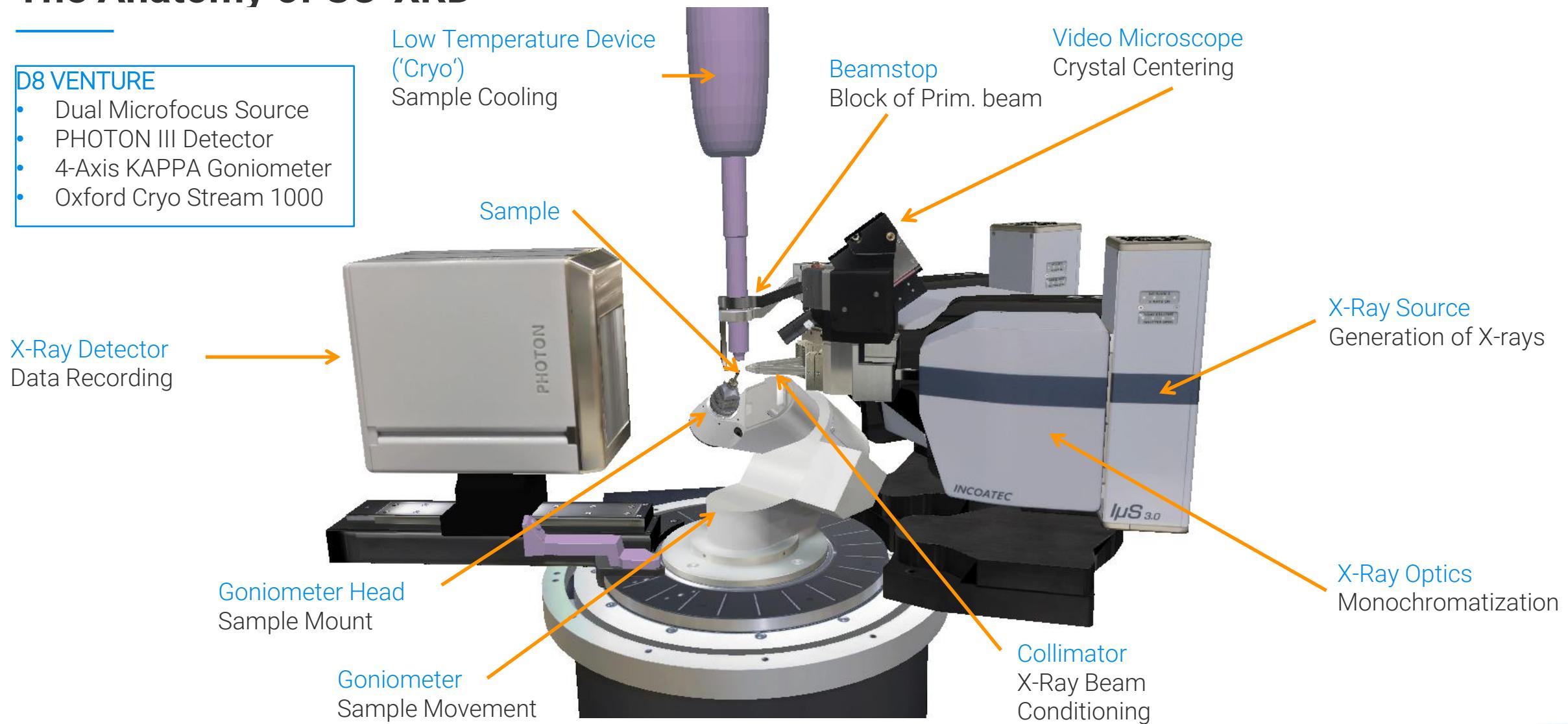
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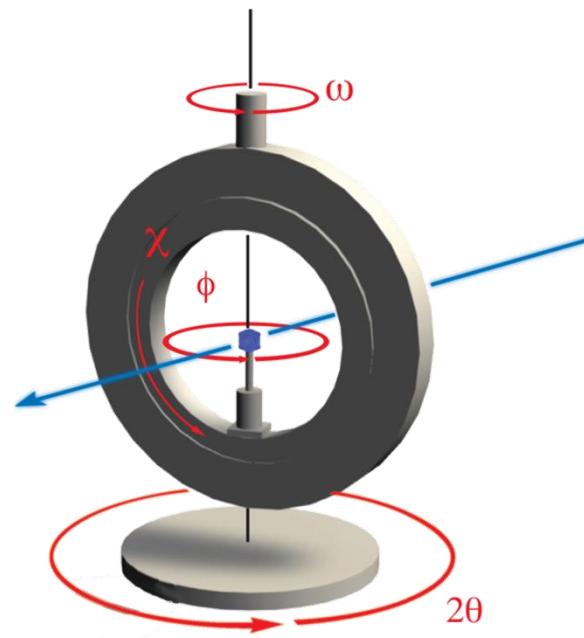
The Anatomy of SC-XRD

D8 VENTURE

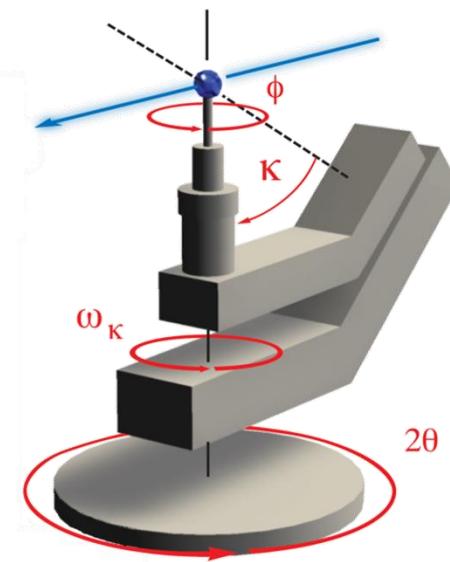
- Dual Microfocus Source
- PHOTON III Detector
- 4-Axis KAPPA Goniometer
- Oxford Cryo Stream 1000



Goniometer Geometry

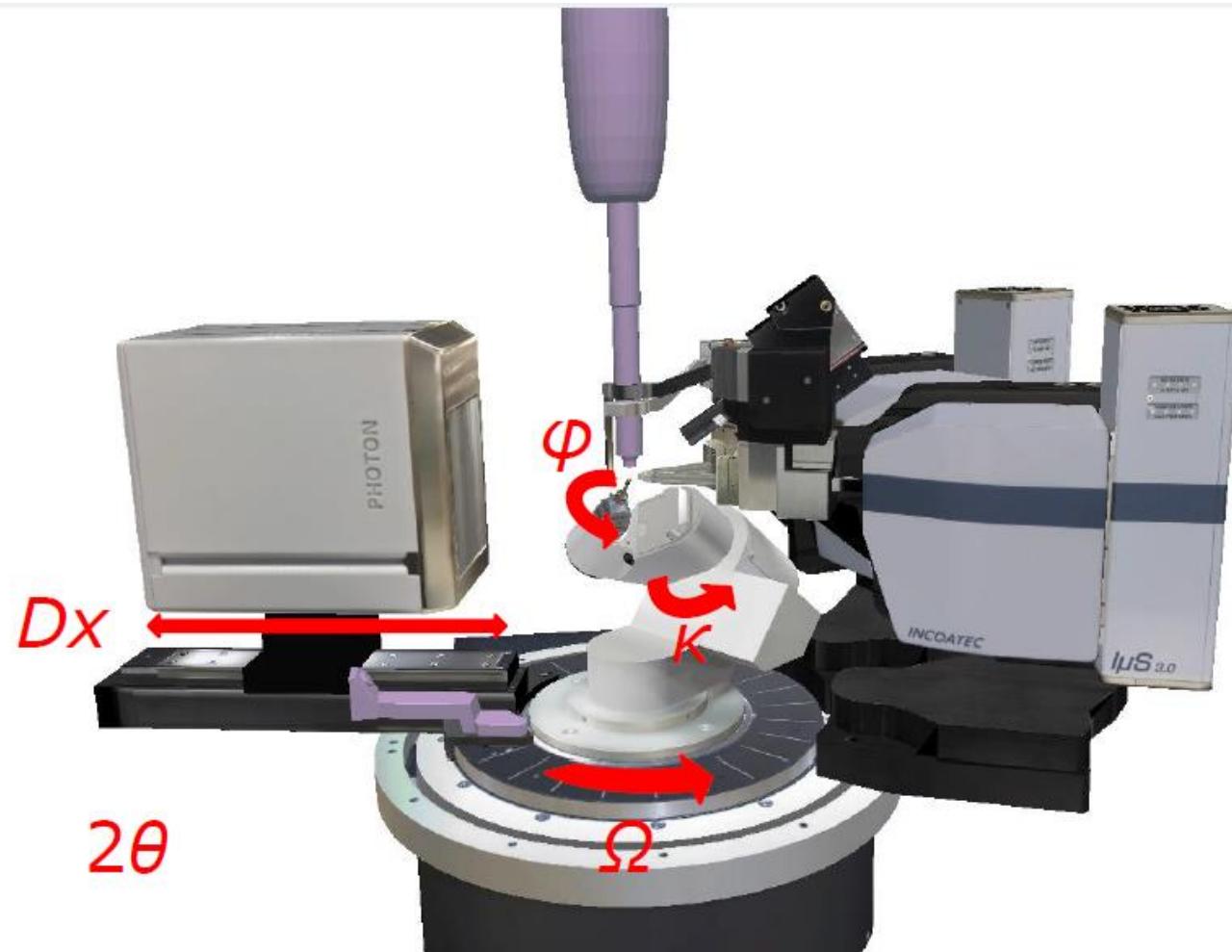


Eulerian Geometry



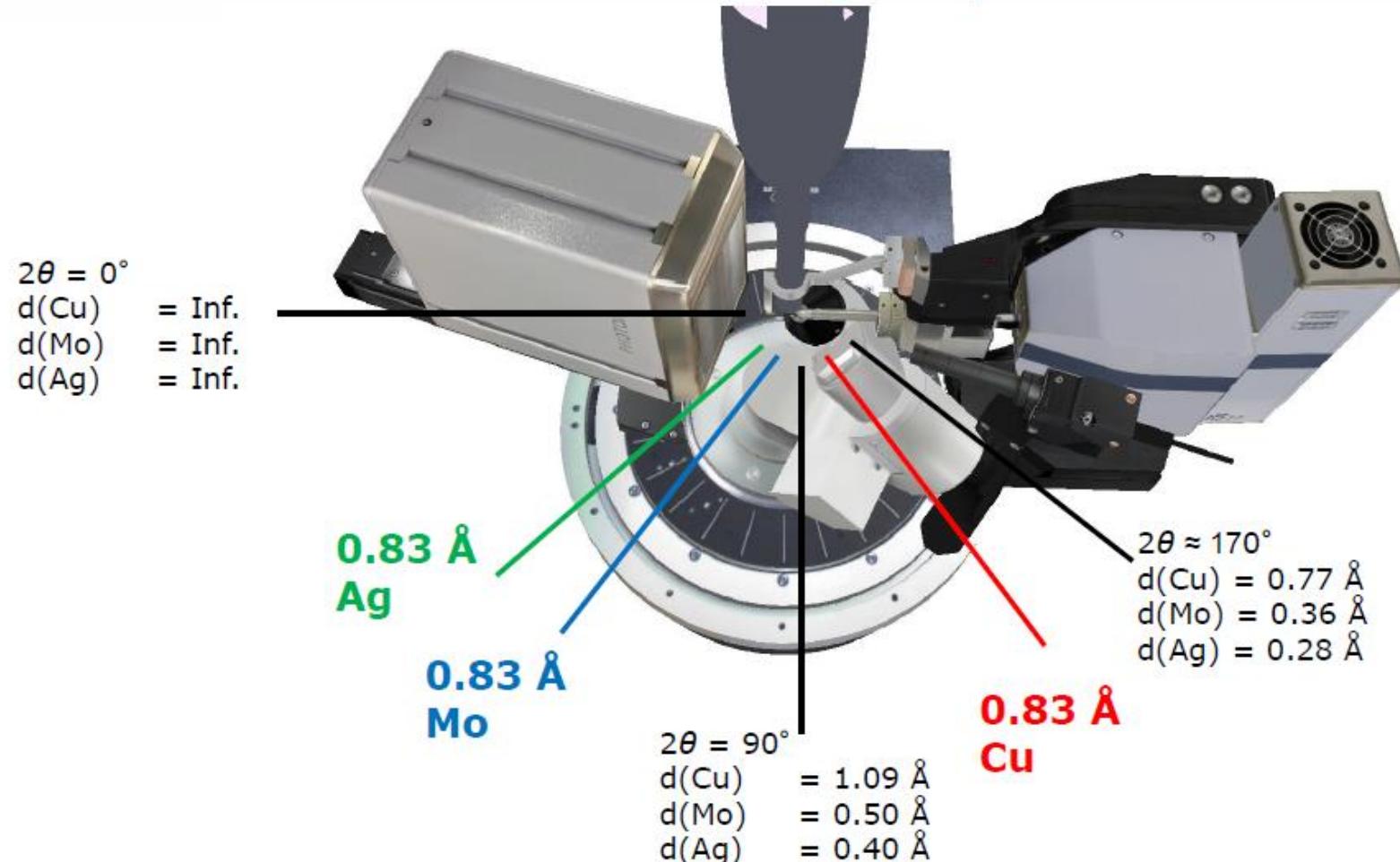
KAPPA Geometry

The Angles of SC-XRD



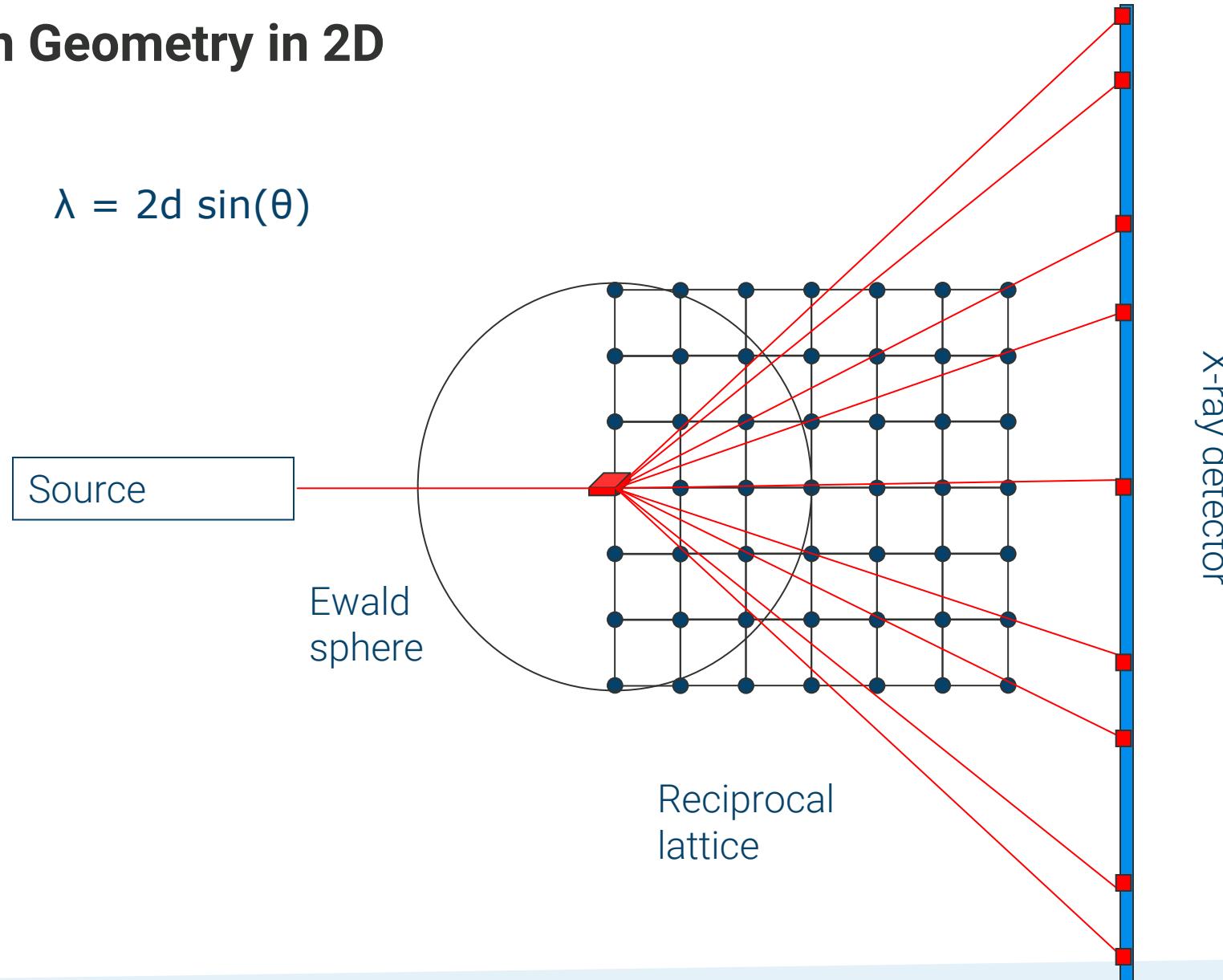
Wavelength and Source

Accessible Resolution is Wavelength dependent

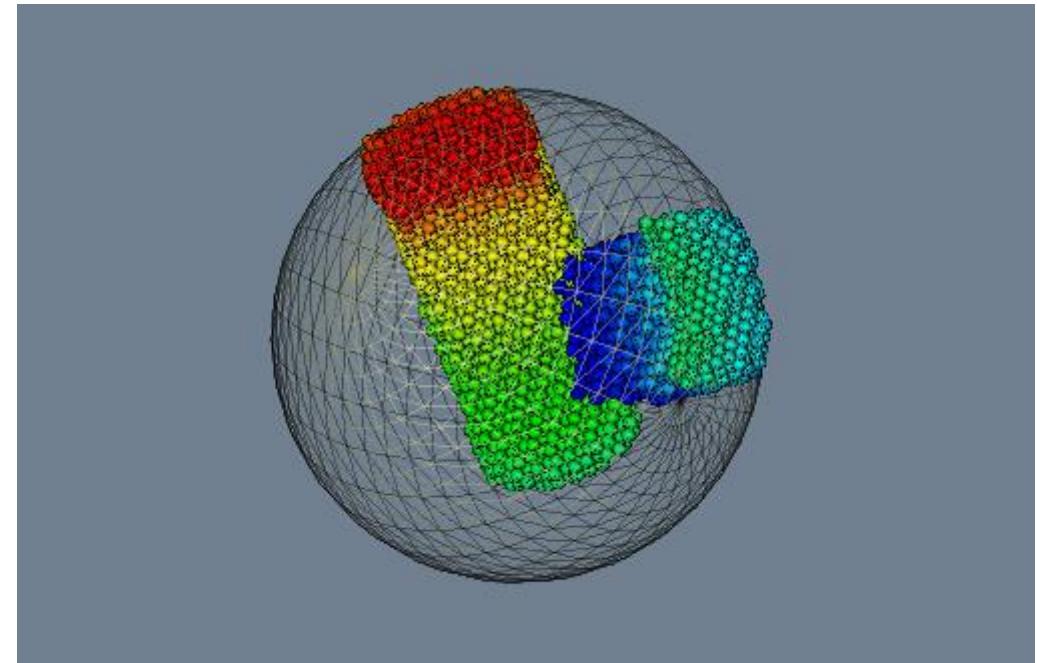
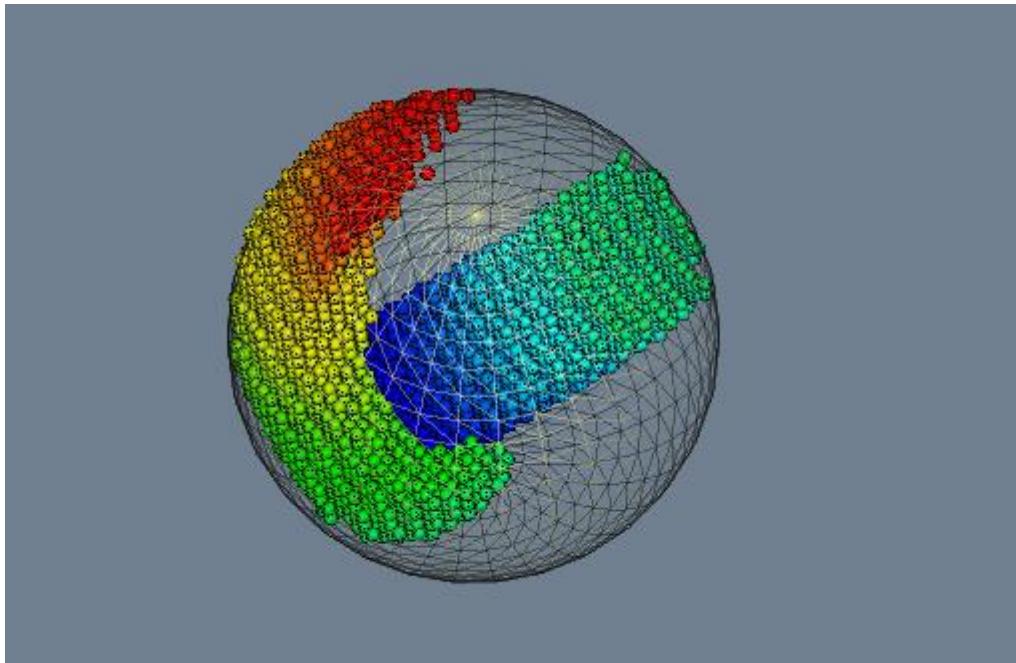


Diffraction Geometry in 2D

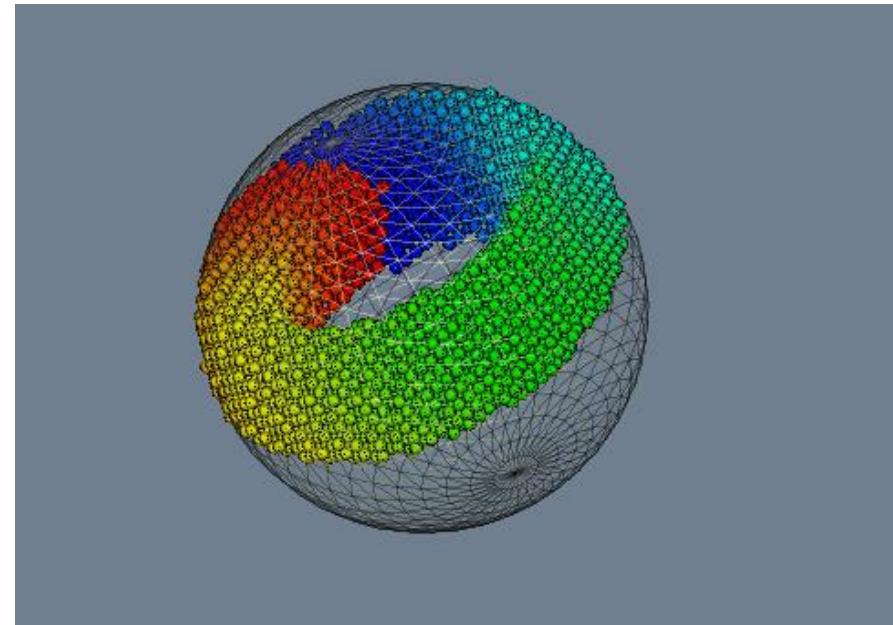
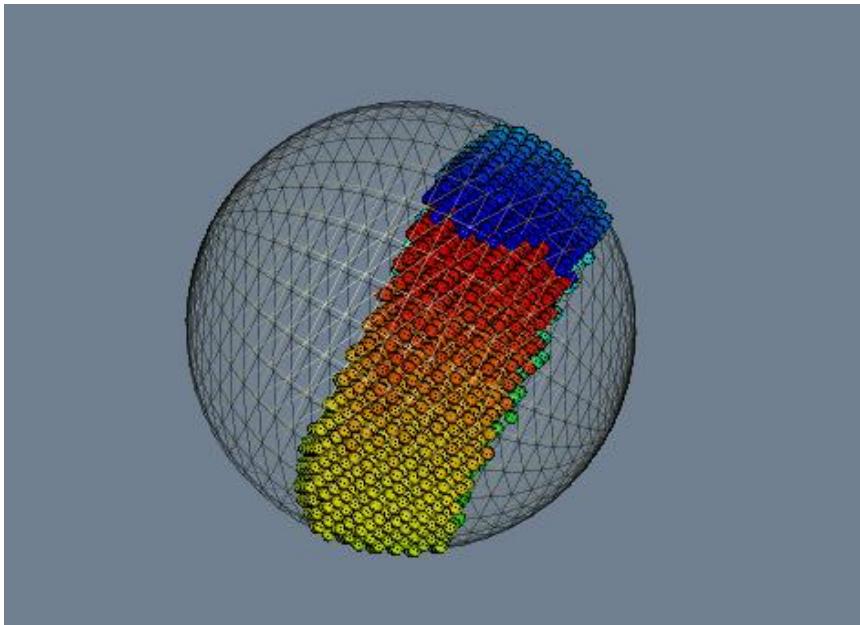
$$\lambda = 2d \sin(\theta)$$



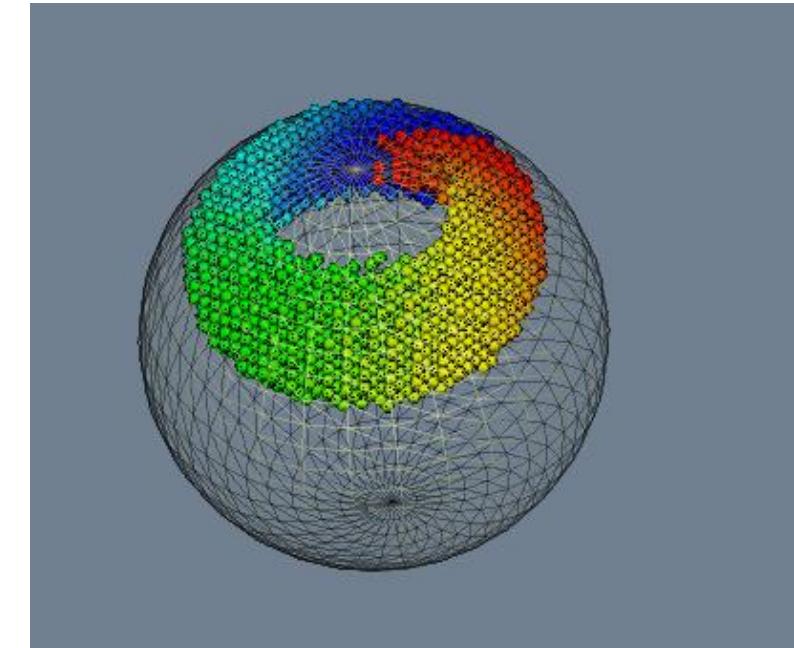
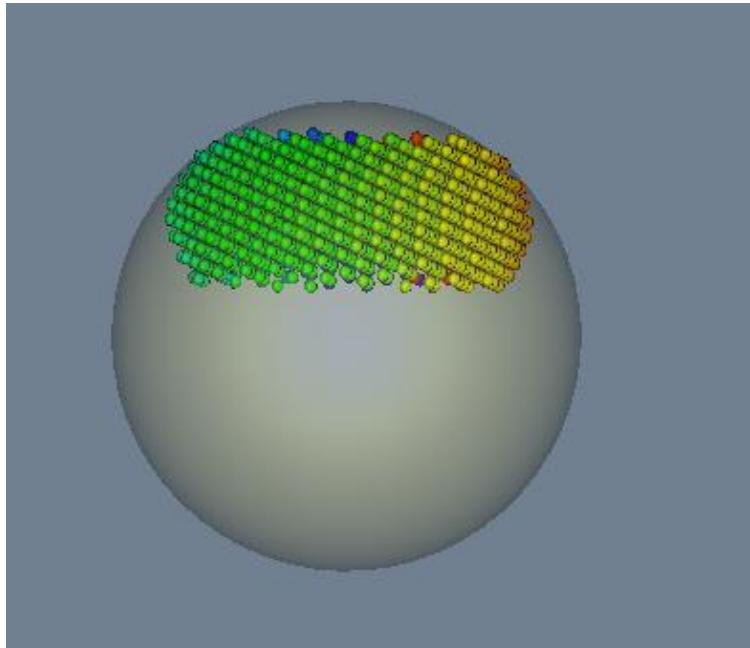
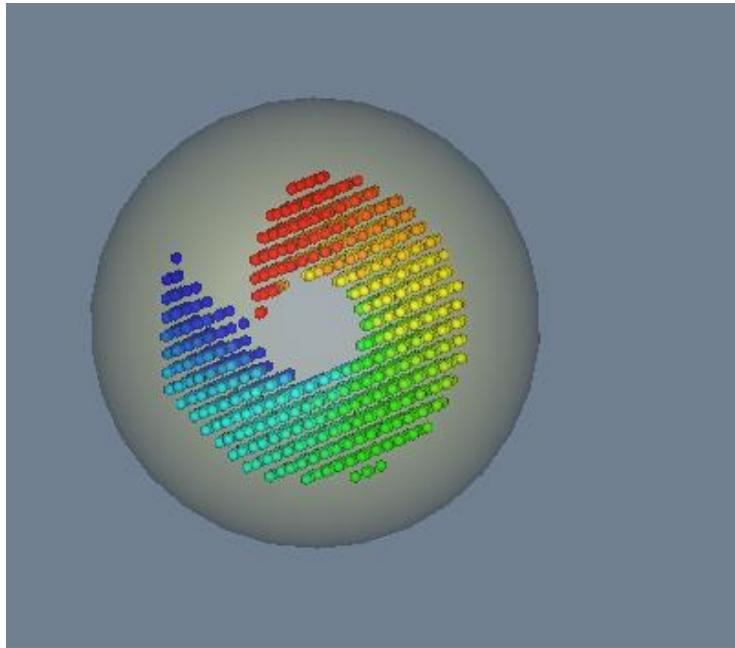
Omega scans



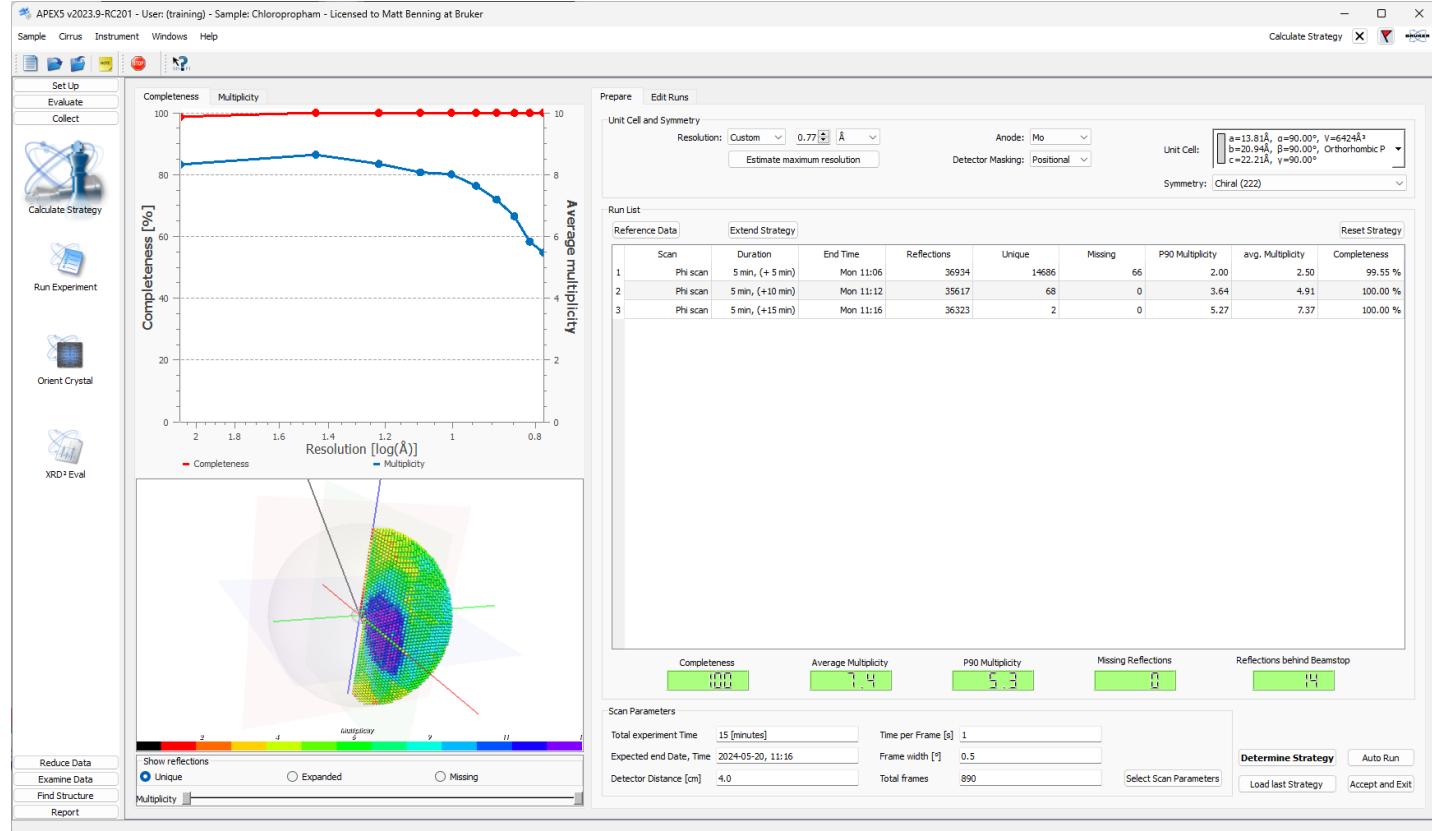
Phi Scan



Phi Scan



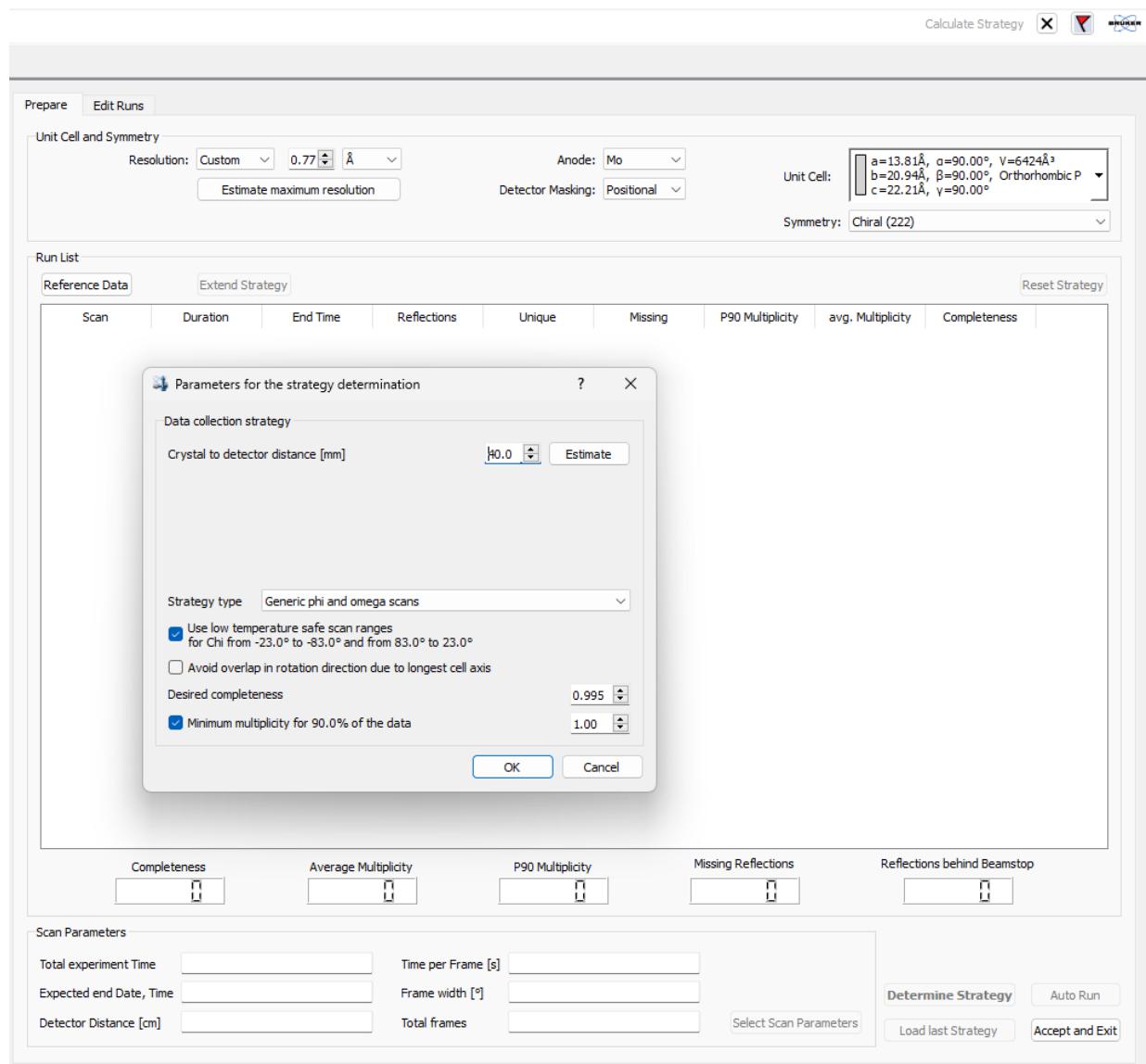
Automated Strategy Determination



- Completeness
- Multiplicity
- Speed
- ETA
- What do you want from strategy?

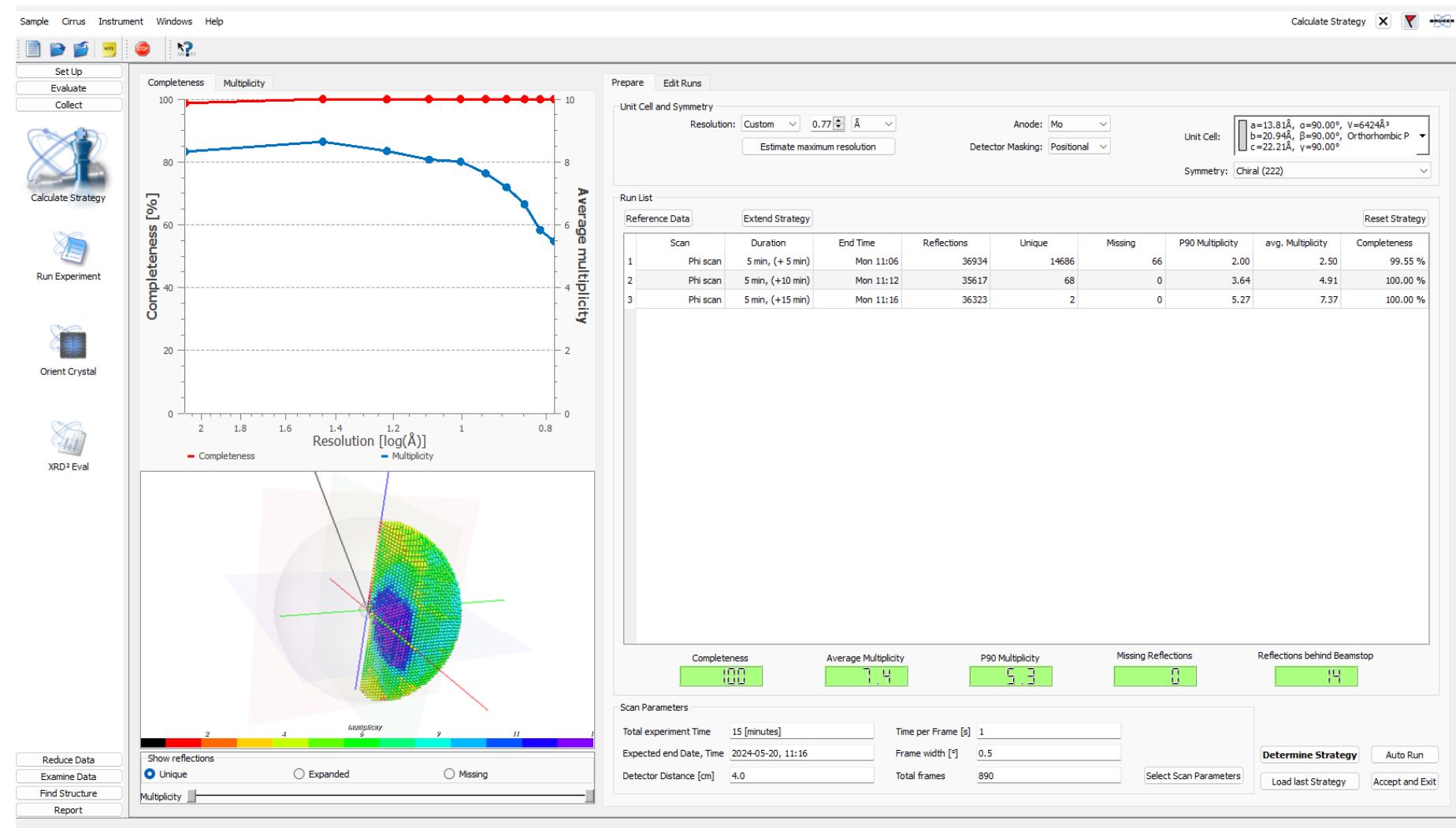
Data Collection Strategy

- Software reads in the cell and sets symmetry to lowest point group in crystal system
- Suggests wavelengths and resolution
- You can choose between different measurement types
- Distance is chosen taking unit cell and mosaicity into account
- You can set target completeness and multiplicity
- Use safe angles for low temp data
- Intelligent defaults work well



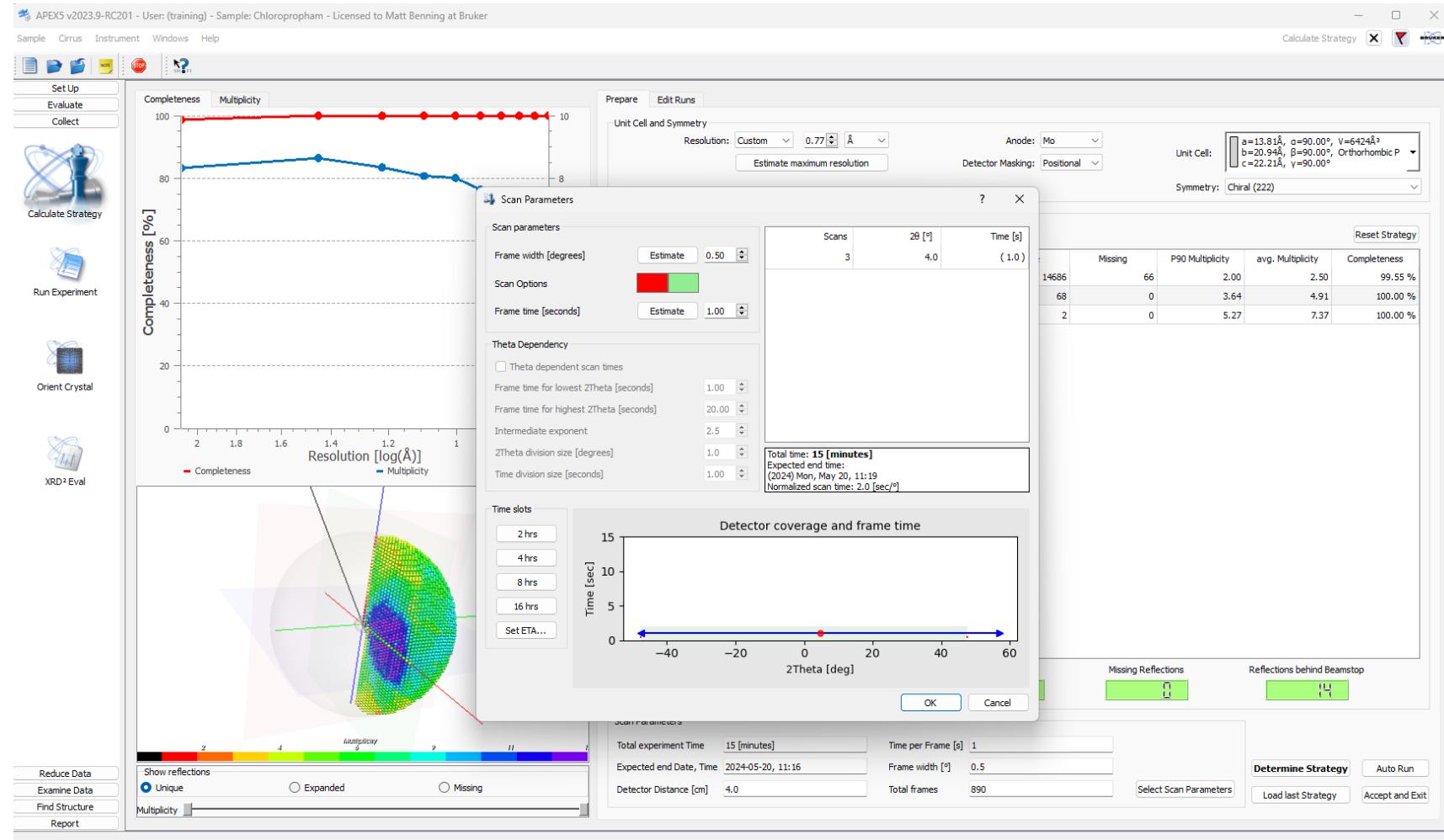
Data Collection Strategy

- Run calculation
- Statistics



Data Collection Strategy

- Scan parameter selection
- Software will estimate
- Frame angle
- Frame time
- 2θ dependent data collection
- Time slots
- Set ETA

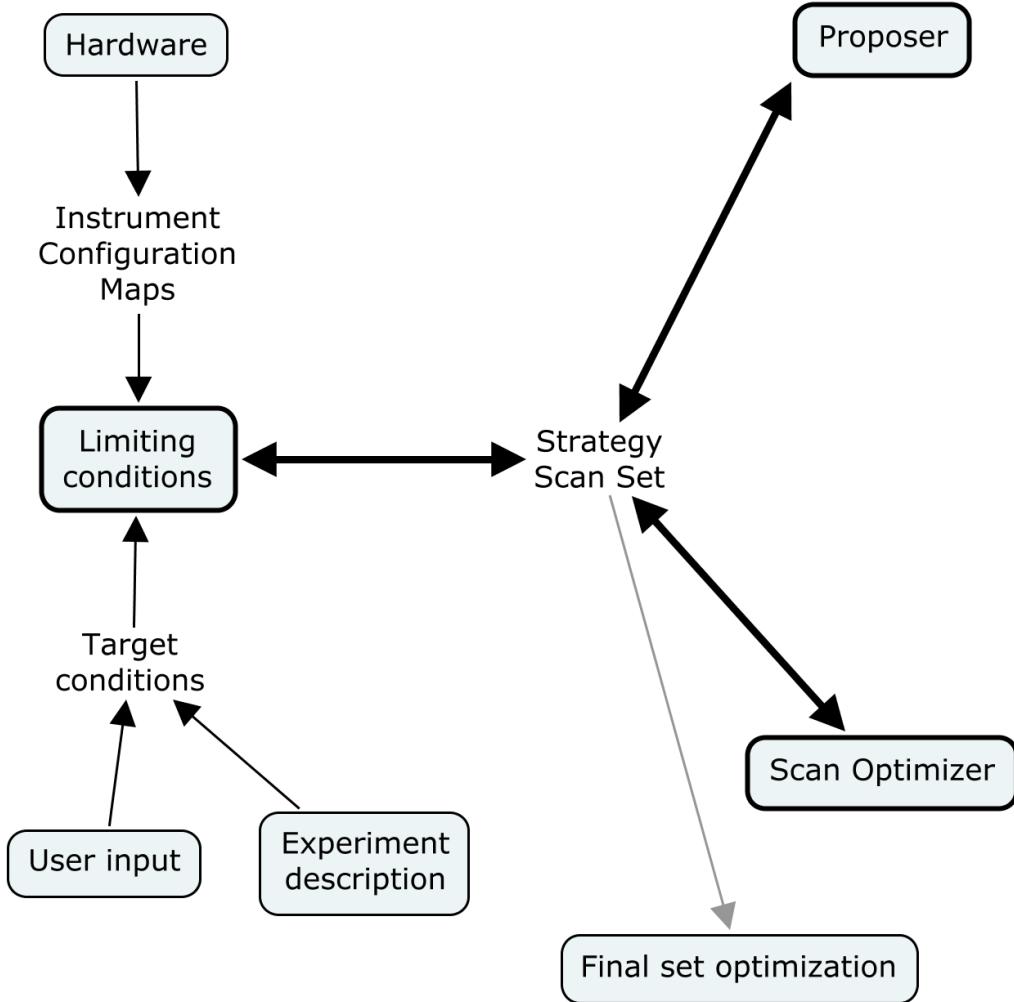


Challenging Cases

- Data Set **Completeness**
 - Crystals with Low Symmetry (Triclinic or Monoclinic)
 - Large Unit Cells (i.e. Large Detector Distances)
 - Unfavorably Mounted Crystals (Spindle || Reciprocal Axis)
 - Blind Detector Regions (Beam Stop, Cryo Nozzle, DAC, ...)
- Data Set **Redundancy**
 - Absorption Correction
 - Anomalous Data (MAD, SAS, SIR, ...)
- Data Collection **Time**
 - Crystal Decay
 - Strict Time Limit
 - Data collection slots

Scan generation

How does it work?



- Form clusters of missing data.
- Turn the clusters into Omega and Phi scans.
- Select the most efficient scan, i.e. the one that covers the largest number of reflections per degree of rotation.
- Repeat

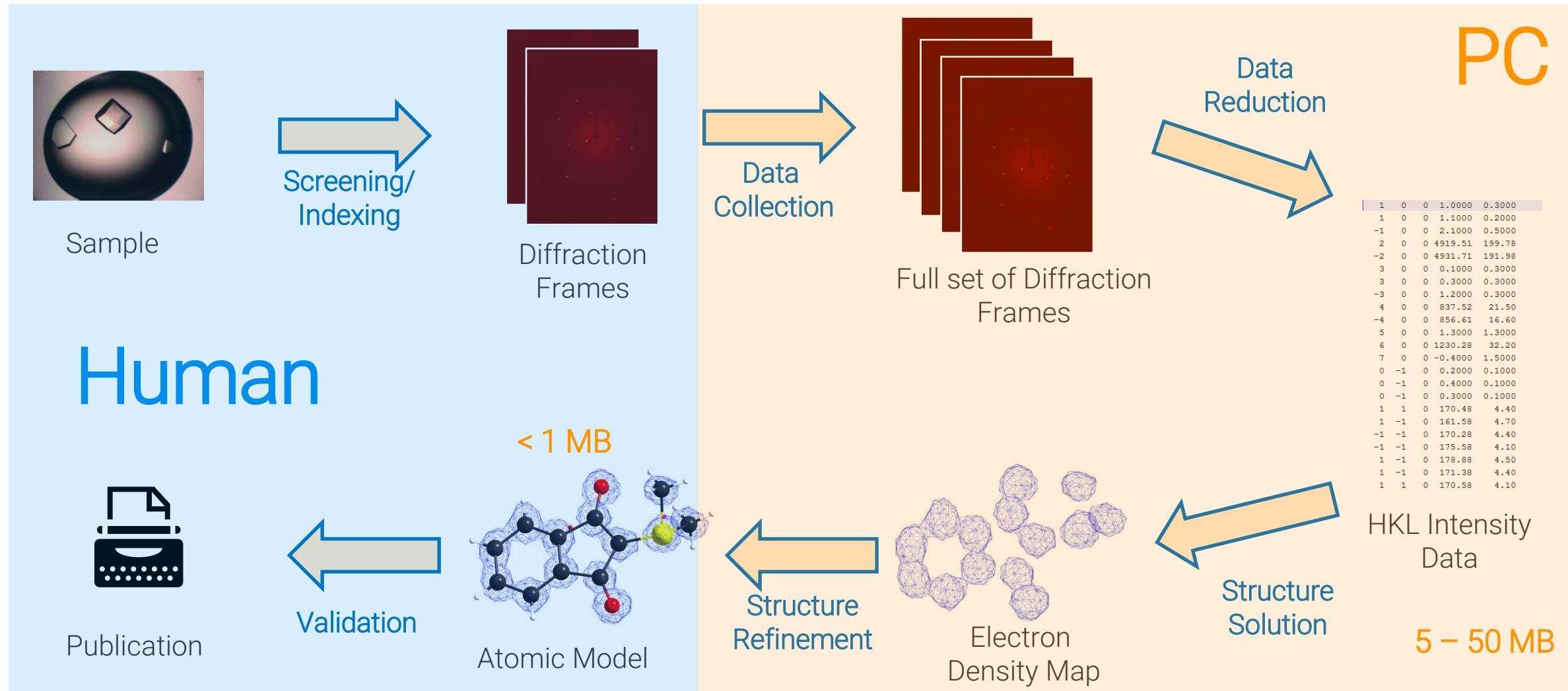


DATA COLLECTION AND REDUCTION WITH APEX6

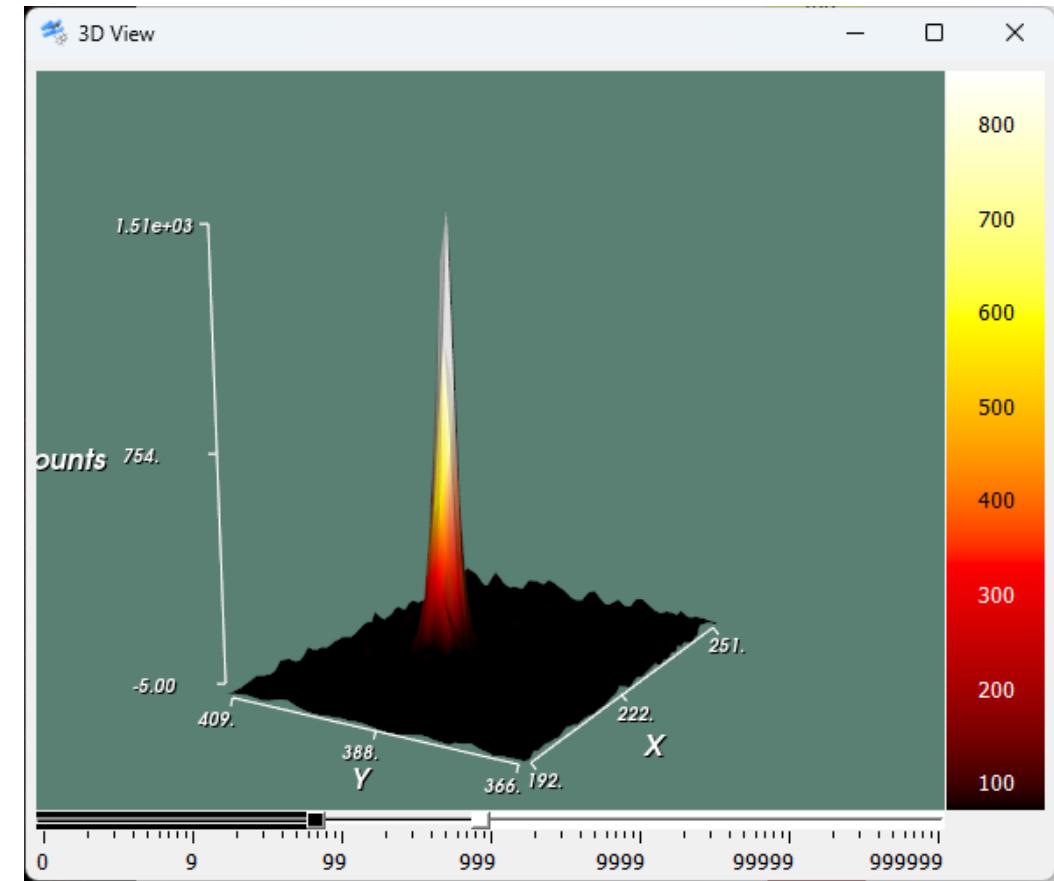
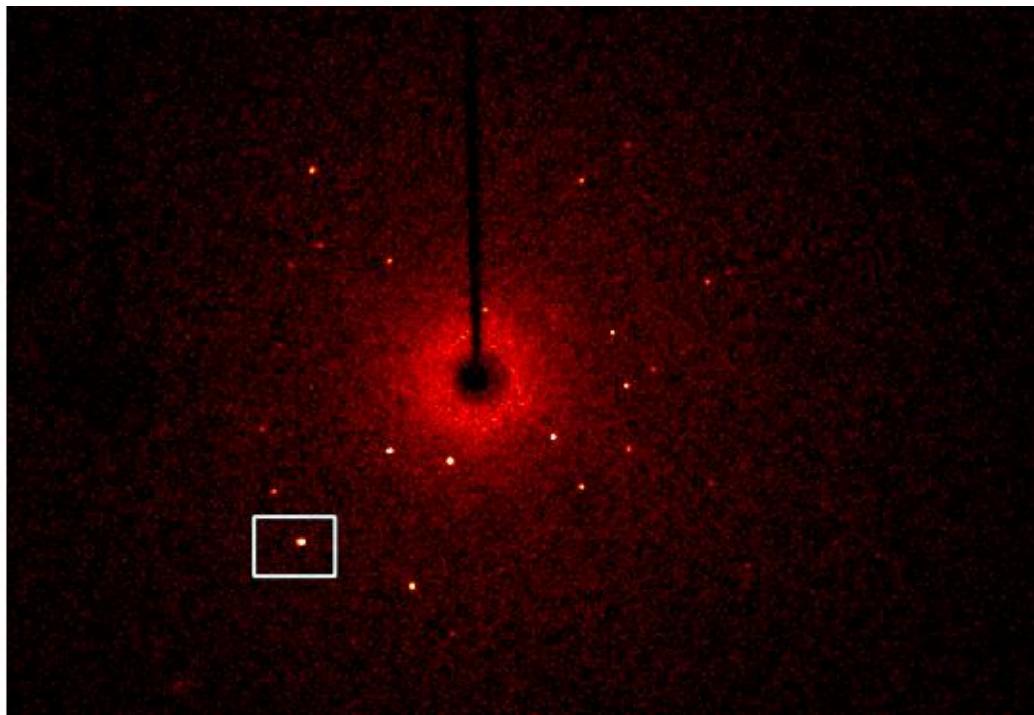
Data Integration with APEX6

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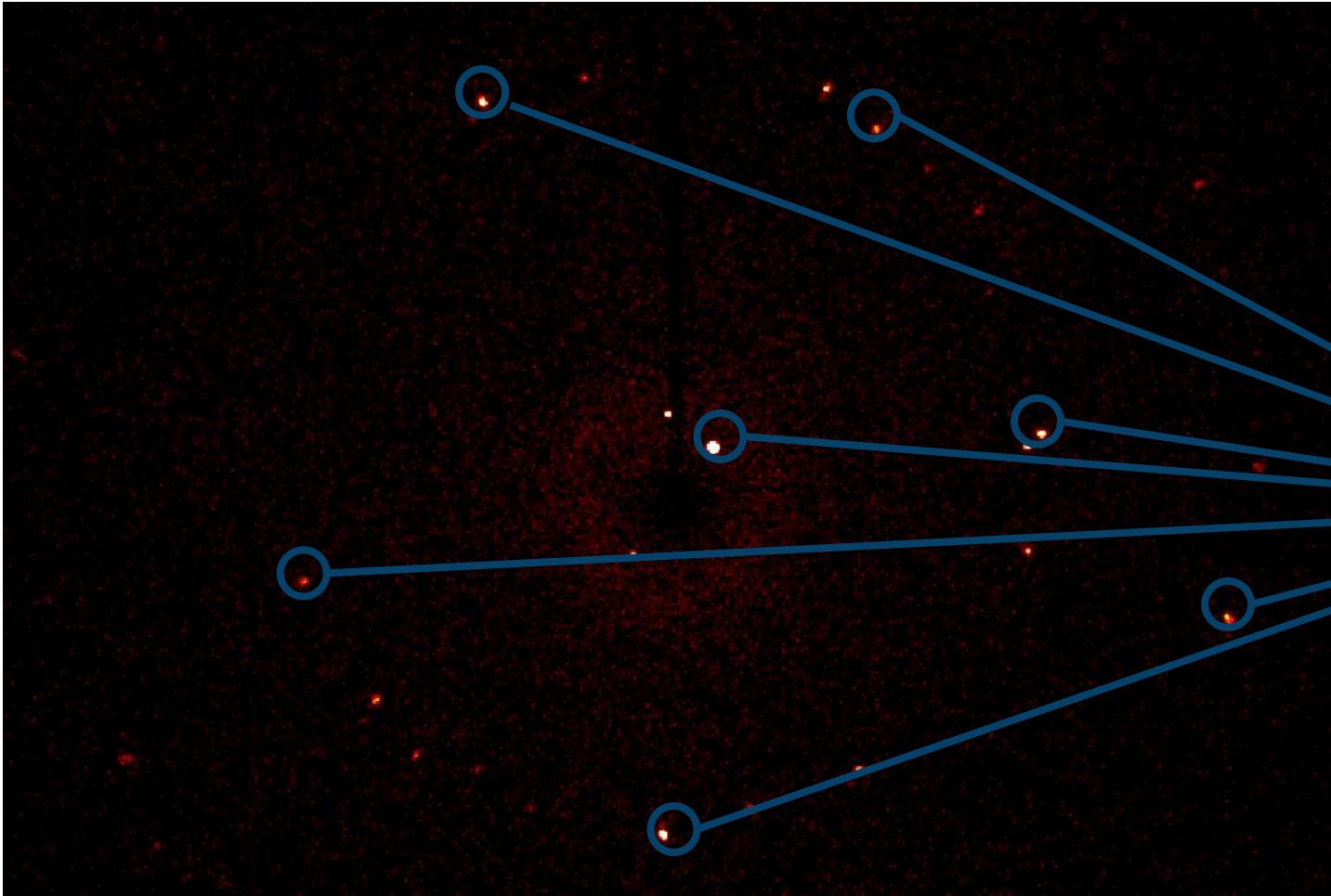
SCD Workflow



3D View of a Reflection



What Does SAINT (Integration Plug-In) Do?



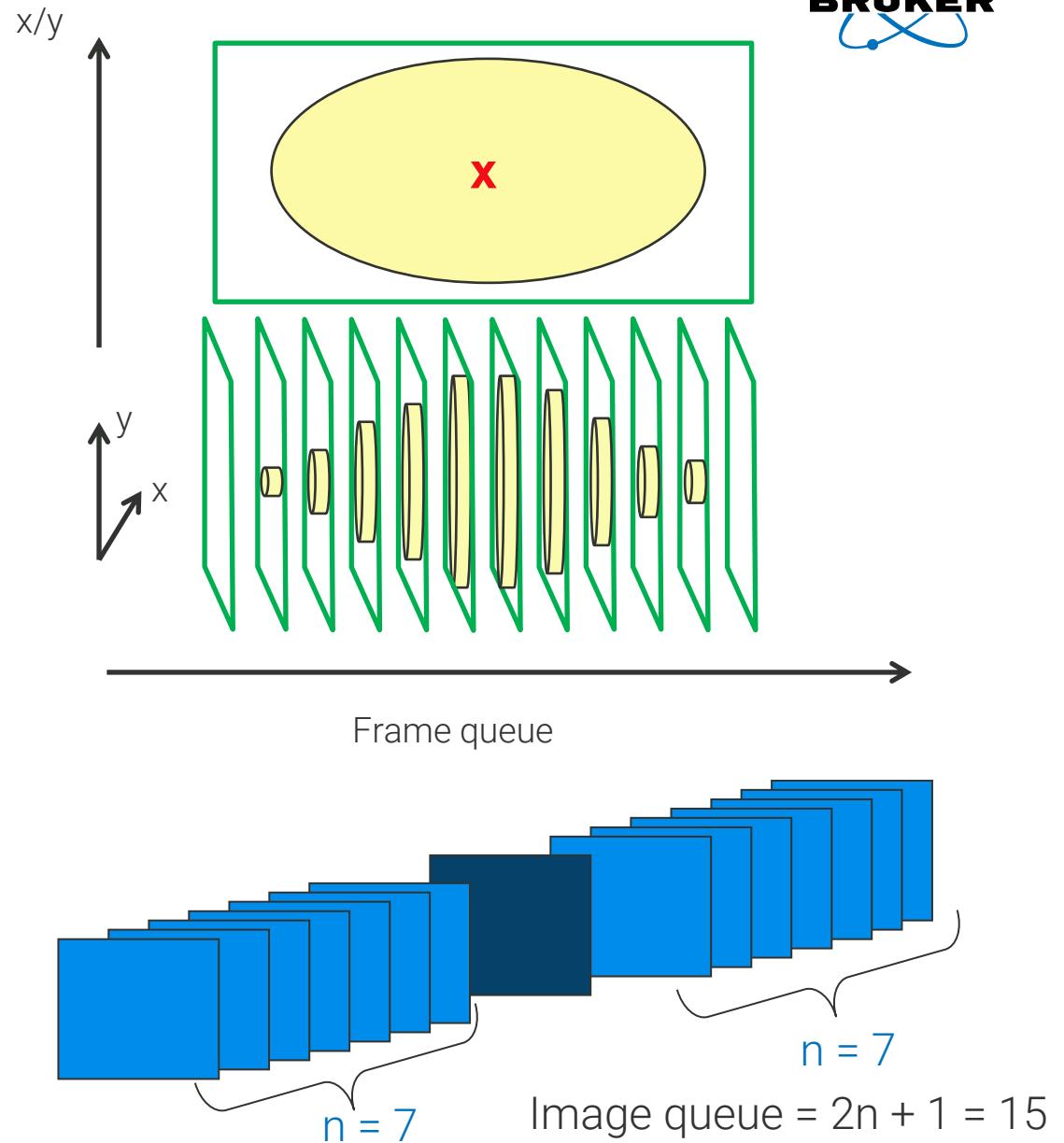
- Integration and data reduction
- Data statistics

Pixel counts

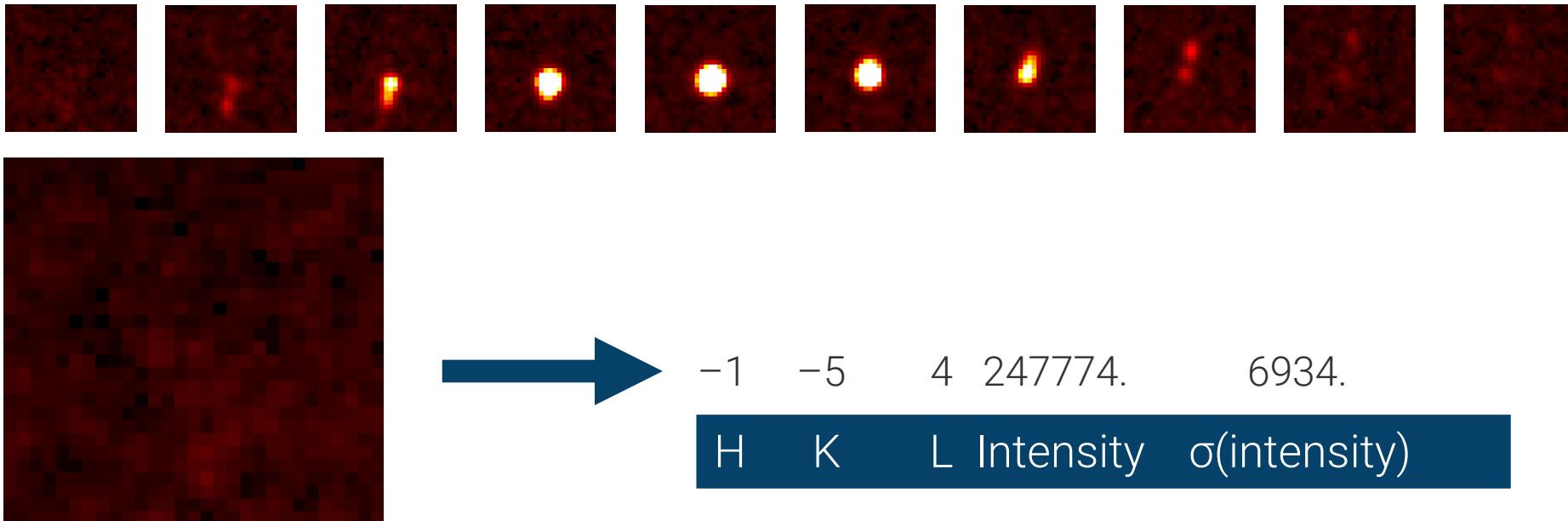
$h, k, l \quad I \quad \sigma(I)$

Data Integration – Steps in Integration

- Which Steps are involved?
 - Determining the background
 - Find out which frames belong to the reflection
 - Is the information complete?
 - Load all required frames in the buffer
 - “Center” the reflection, refine unit cell
 - Determine the best integration box size
 - Analyze the reflection profile
 - Determine the intensity
 - Determine the standard deviation
 - (Re-)Refine the Orientation Matrix

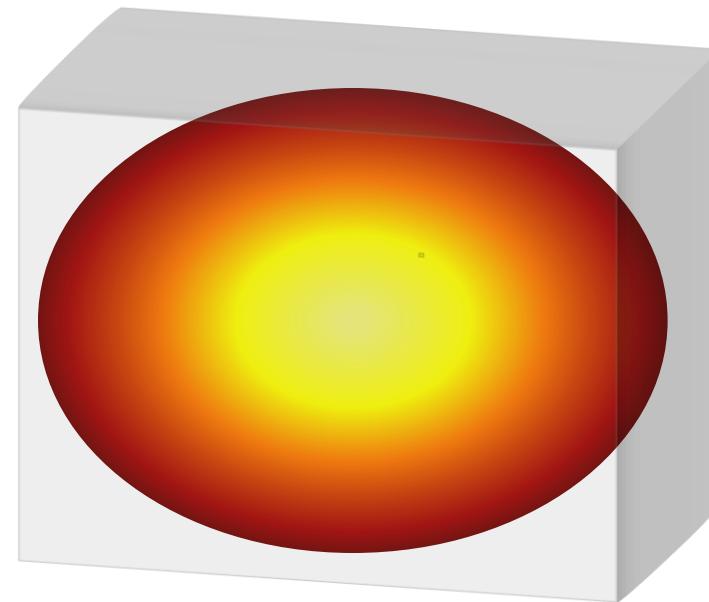


Spot Integration

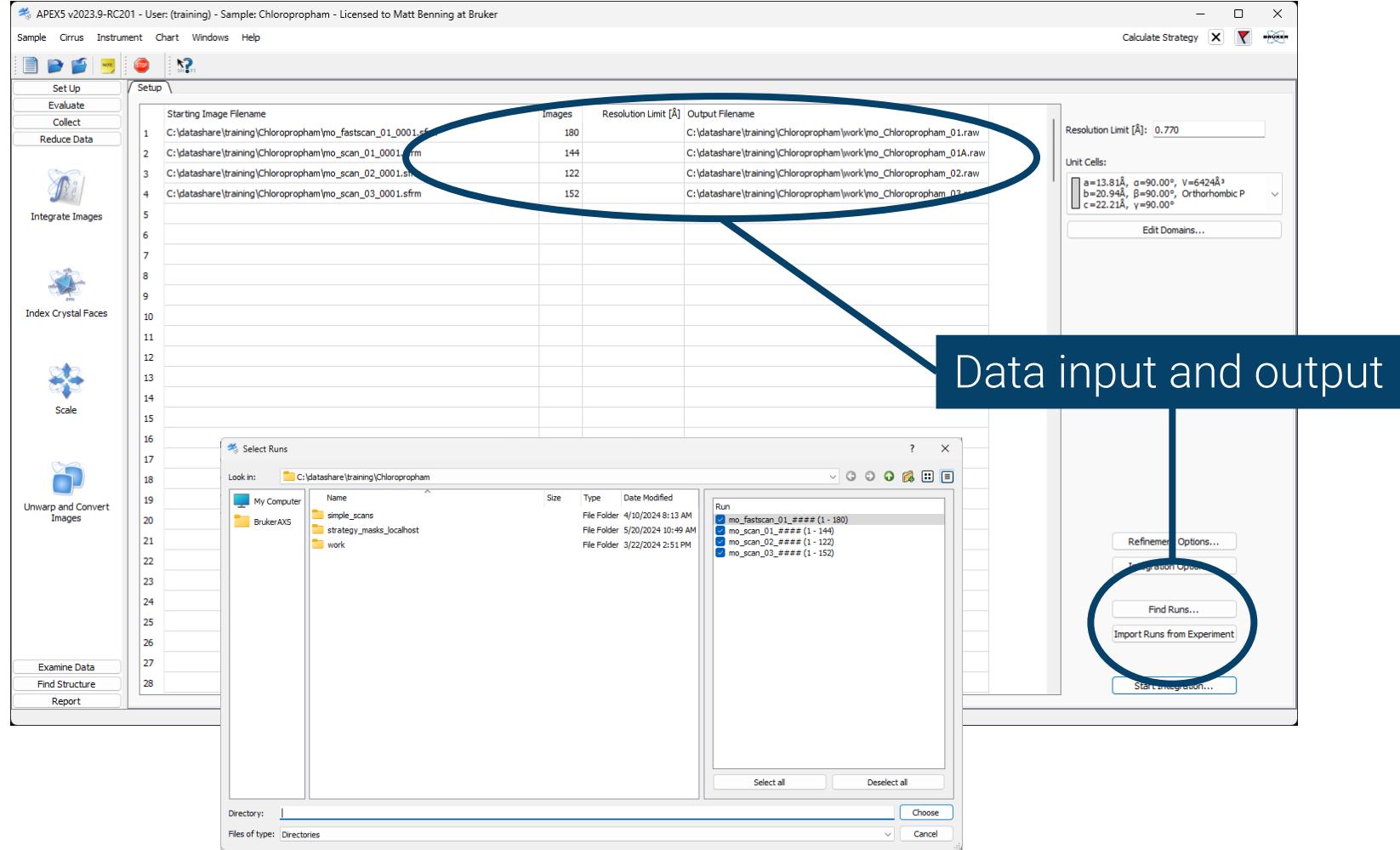


Learned Profiles

- Integration box
- Profile
- Model profiles are built as averages of strong, well-behaved reflections



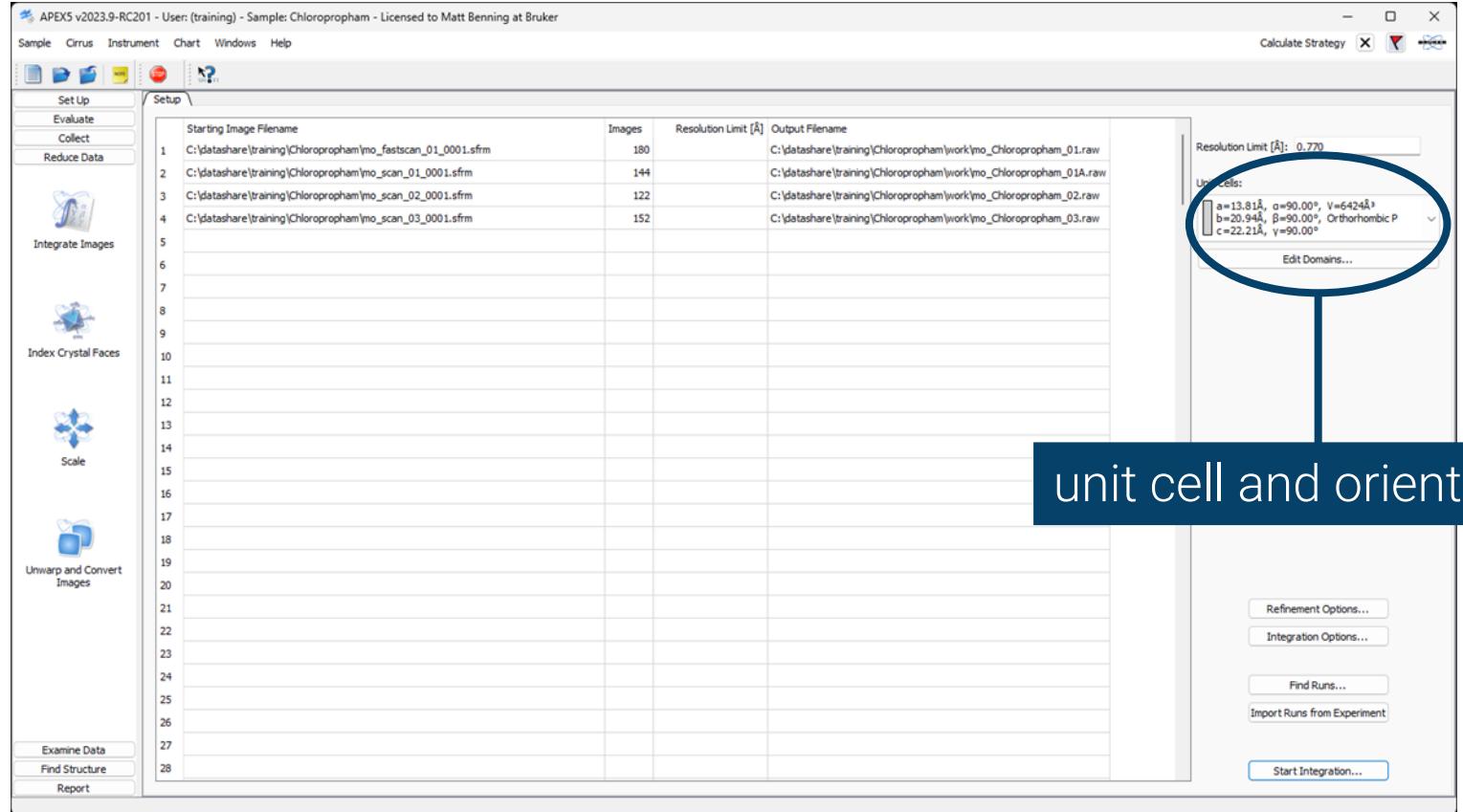
SAINT GUI – Run Selection



- Easy to use
- Supports twinning
- Supports incommensurates
- Intelligent defaults

Data input and output

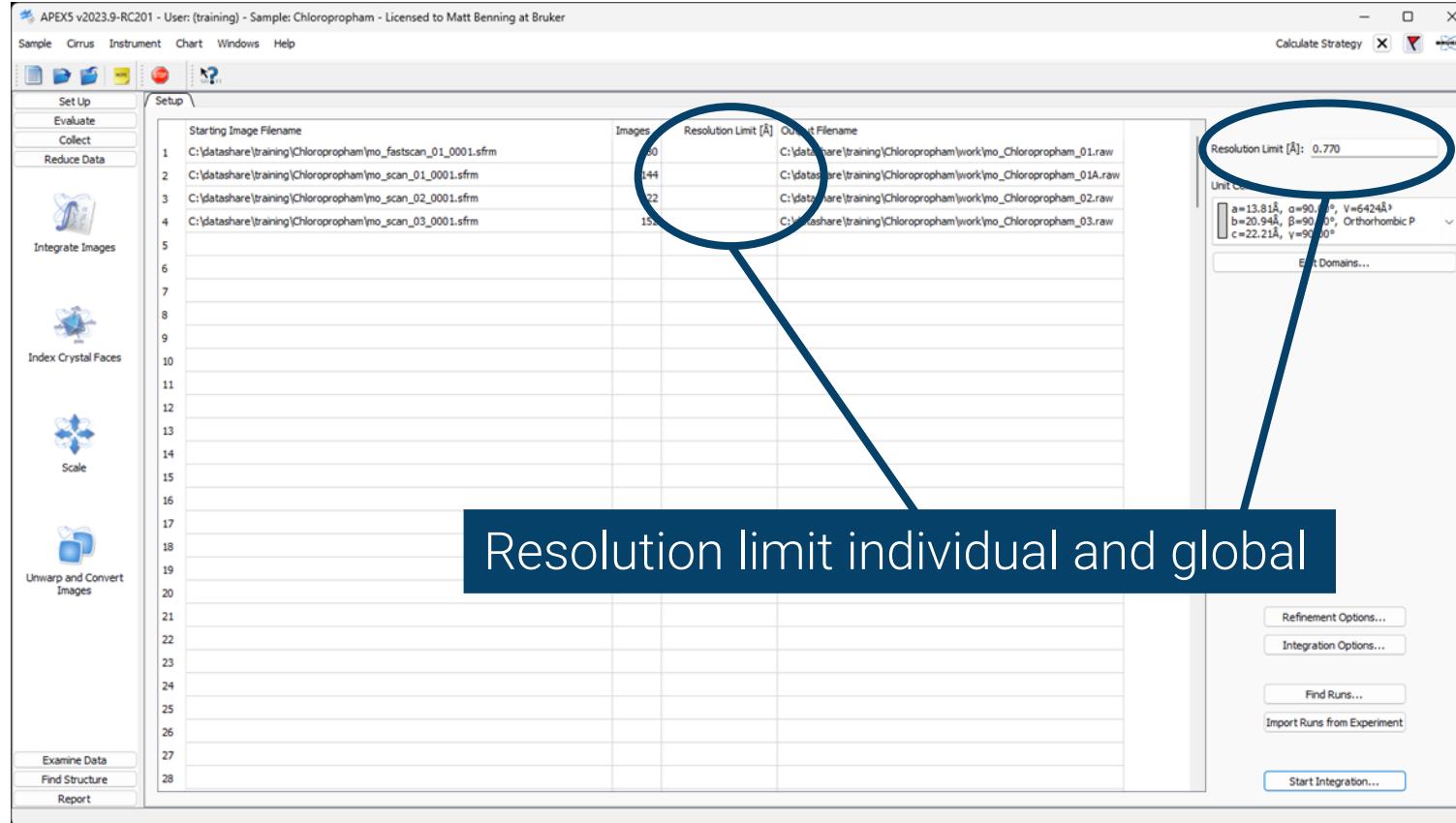
SAINT GUI – Run Selection



- Easy to use
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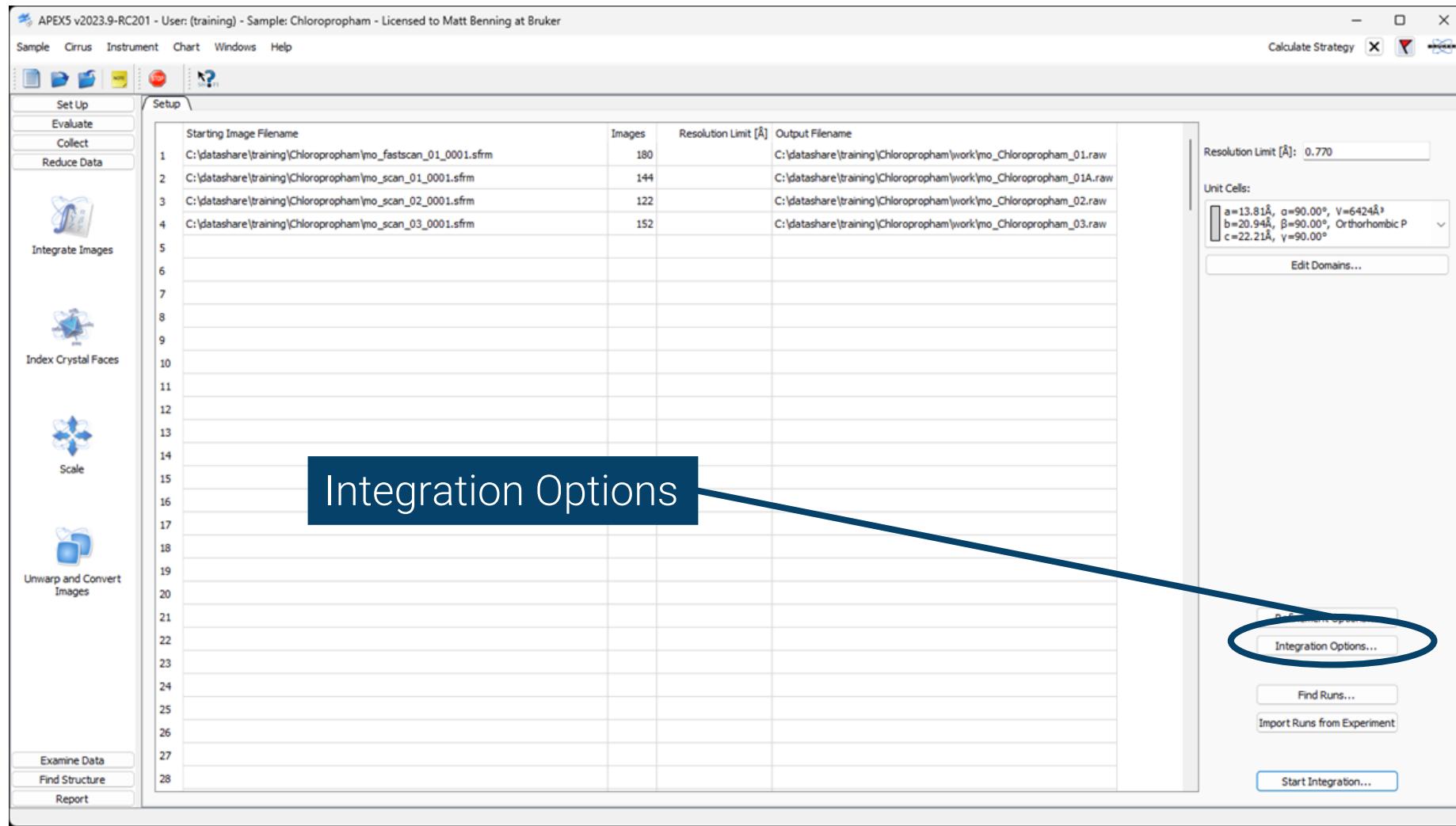
unit cell and orientation

SAINT GUI – Run Selection



- Choose a reasonable resolution limit!
- Repeat after looking at data statistics
- Recycle the orientation matrix (import *m.p4p)
- Don't integrate noise

SAINT – Integration Options

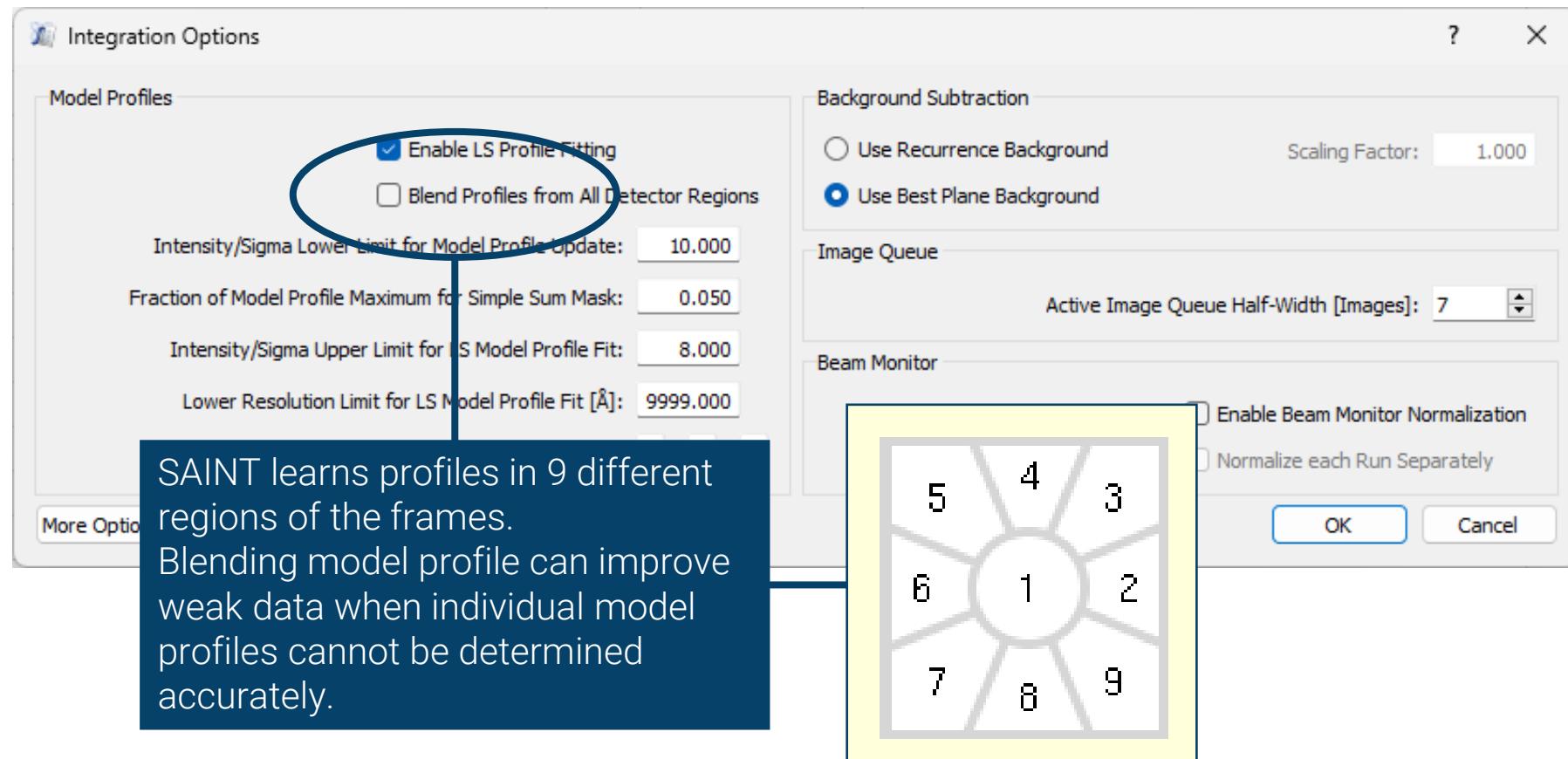


The image shows the APEX5 software interface for data collection and reduction. The main window title is "APEX5 v2023.9-RC201 - User: (training) - Sample: Chloroprophan - Licensed to Matt Benning at Bruker". The menu bar includes Sample, Cirrus, Instrument, Chart, Windows, Help, and Calculate Strategy. On the left, there is a vertical toolbar with icons for Set Up, Evaluate, Collect, Reduce Data, Integrate Images, Index Crystal Faces, Scale, Unwarp and Convert Images, Examine Data, Find Structure, and Report. The central workspace is titled "Setup" and contains a table with the following data:

	Starting Image Filename	Images	Resolution Limit [Å]	Output Filename
1	C:\datashare\training\Chloroprophan\mo_fastscan_01_0001.sfrm	180		C:\datashare\training\Chloroprophan\work\mo_Chloroprophan_01.raw
2	C:\datashare\training\Chloroprophan\mo_scan_01_0001.sfrm	144		C:\datashare\training\Chloroprophan\work\mo_Chloroprophan_01A.raw
3	C:\datashare\training\Chloroprophan\mo_scan_02_0001.sfrm	122		C:\datashare\training\Chloroprophan\work\mo_Chloroprophan_02.raw
4	C:\datashare\training\Chloroprophan\mo_scan_03_0001.sfrm	152		C:\datashare\training\Chloroprophan\work\mo_Chloroprophan_03.raw
5				
6				
7				
8				
9				
10				
11				
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17				
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26				
27				
28				

A blue callout box labeled "Integration Options" points to the "Integration Options..." button in the bottom right corner of the workspace. This button is highlighted with a blue oval. Below it are buttons for "Find Runs...", "Import Runs from Experiment", and "Start Integration...". To the right of the workspace, there is a sidebar with "Resolution Limit [Å]: 0.770" and "Unit Cells" information: $a=13.81\text{\AA}$, $\alpha=90.00^\circ$, $V=6424\text{\AA}^3$, $b=20.94\text{\AA}$, $\beta=90.00^\circ$, Orthorhombic P, $c=22.21\text{\AA}$, $\gamma=90.00^\circ$. There are also "Edit Domains..." and "Calculate Strategy" buttons.

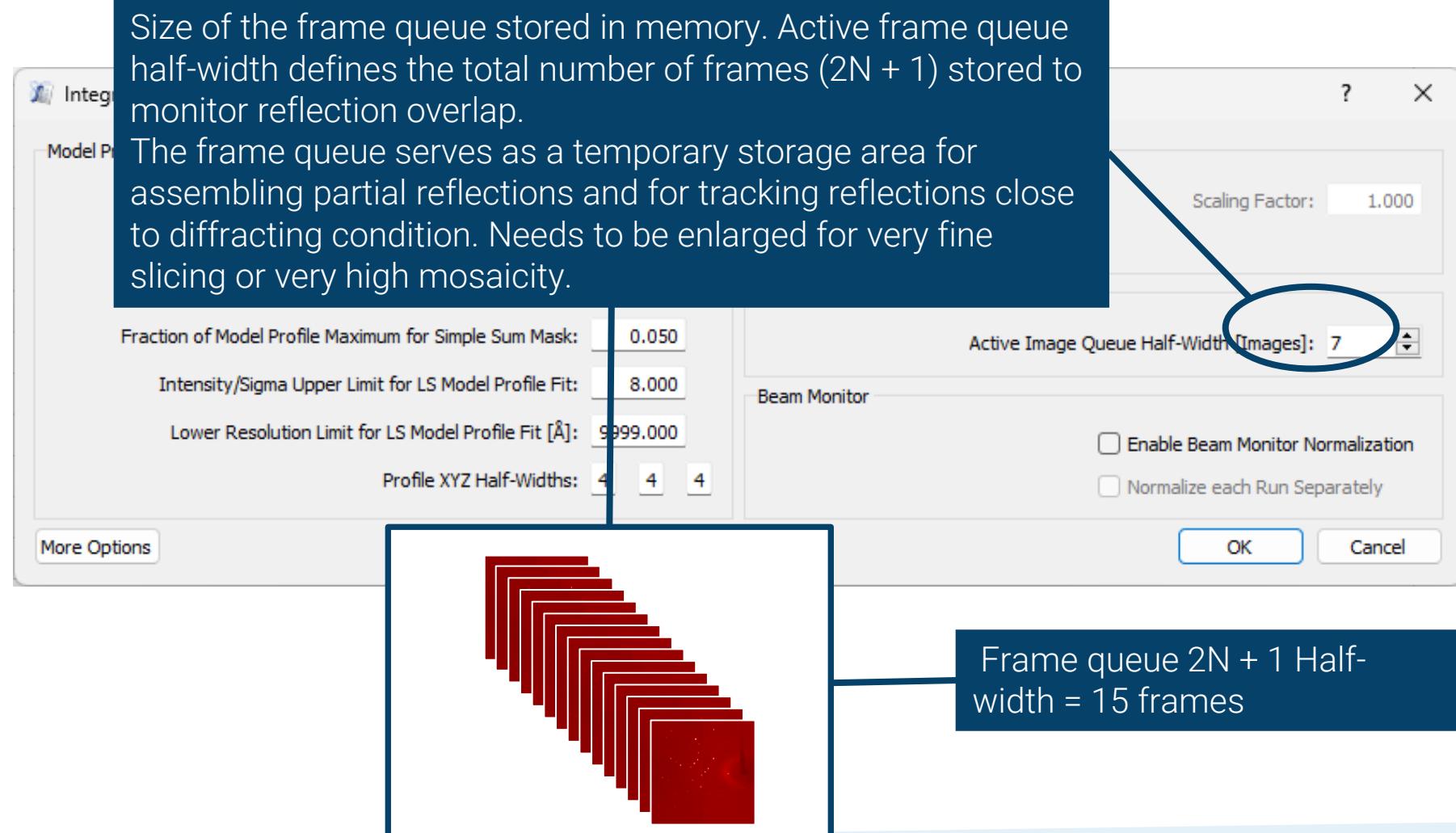
SAINT – Integration Options



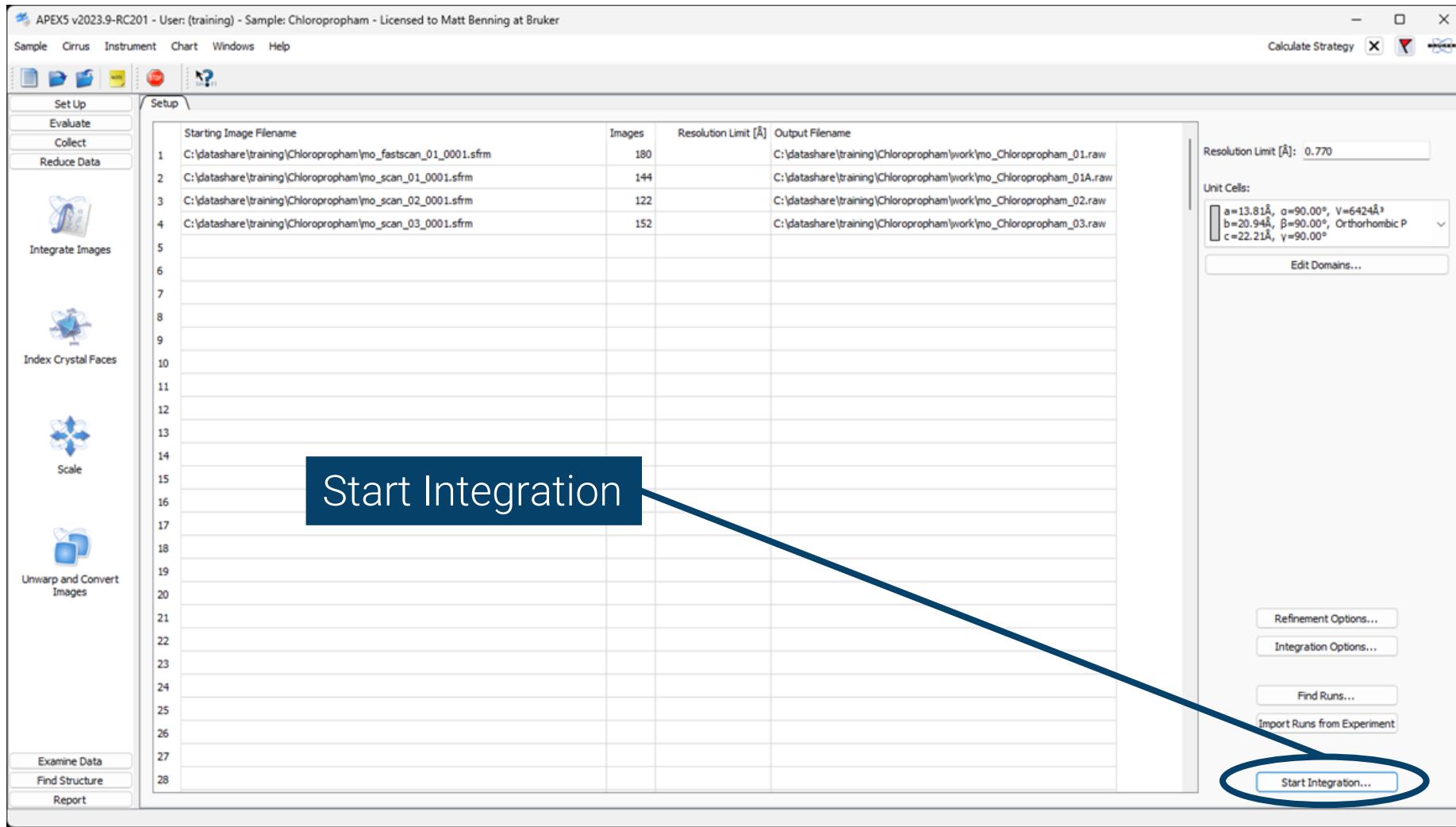
SAINT – Integration Options

Size of the frame queue stored in memory. Active frame queue half-width defines the total number of frames ($2N + 1$) stored to monitor reflection overlap.

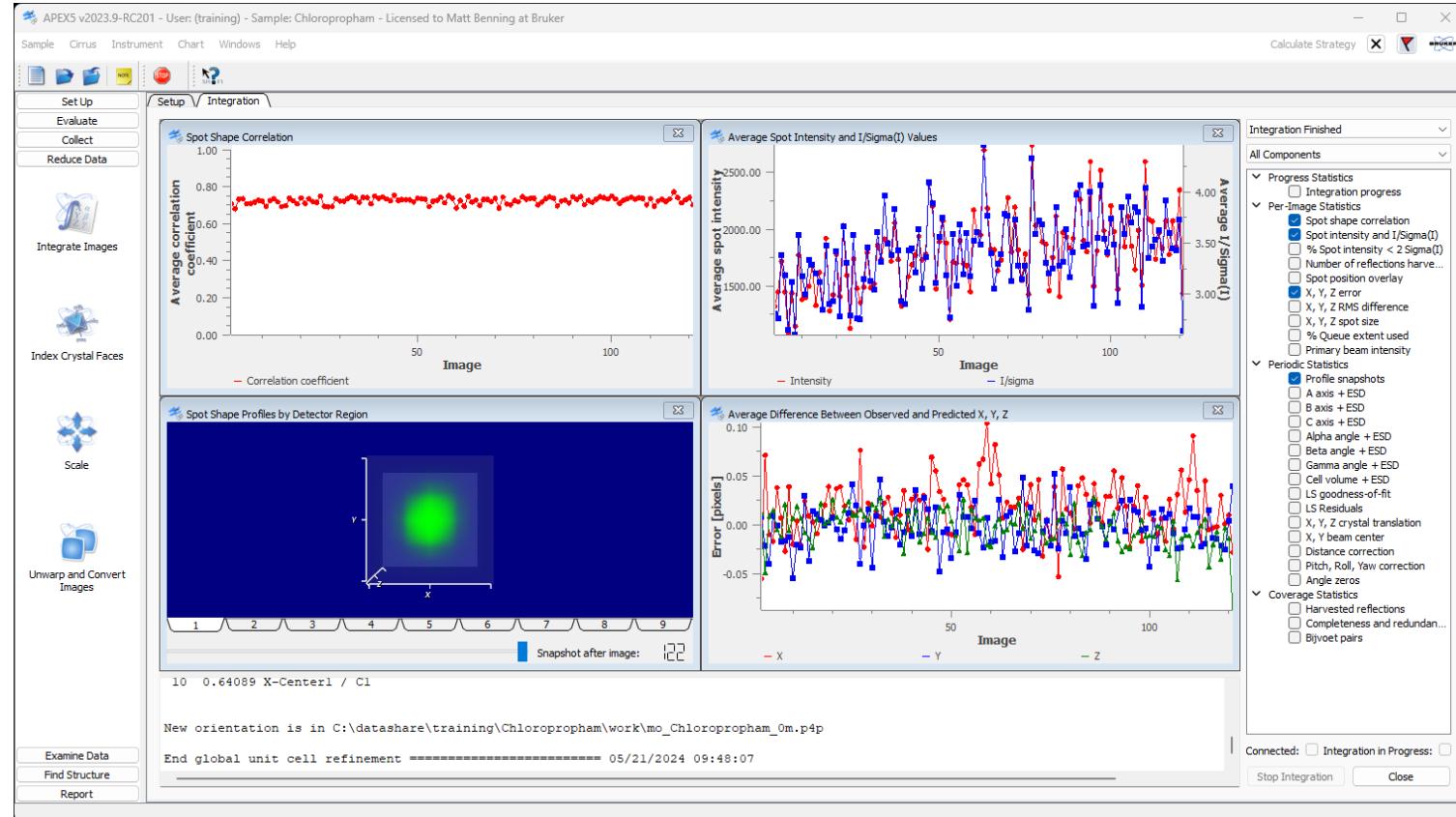
The frame queue serves as a temporary storage area for assembling partial reflections and for tracking reflections close to diffracting condition. Needs to be enlarged for very fine slicing or very high mosaicity.



SAINT – Let's Integrate

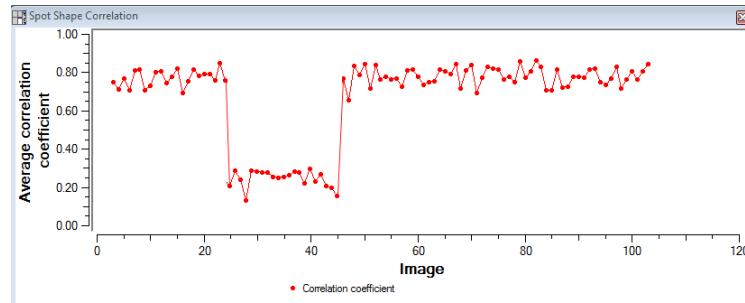
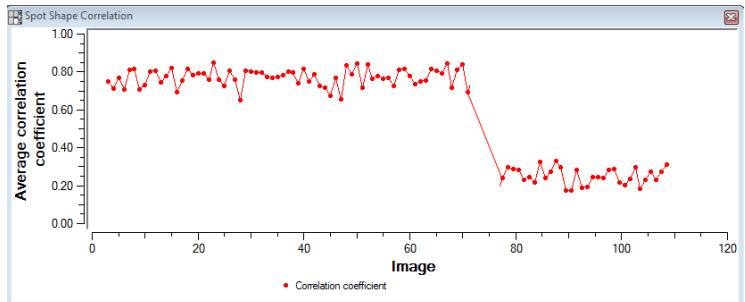
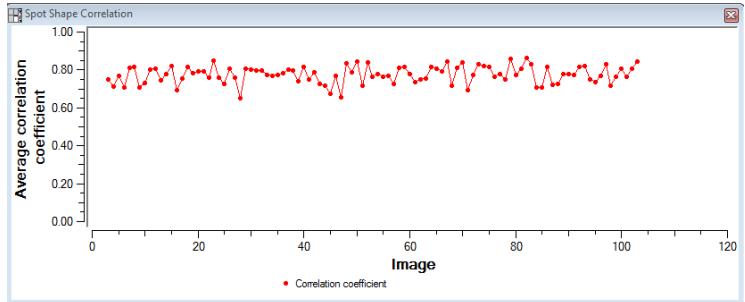


SAINT CHART



- Most important parameters at a glance
- Spot correlation should be high and not change much during the scan
- If model profiles are white a default profile is used – consider blending
- X-Y-Z errors should not drift

Correlation Coefficient



- Good run
- Reduce number of images to be integrated (click on spot for image number)
- Create two runs for integration and exclude bad part

Data Integration – The *_0m._ls File

Spots with topped/rescanned pixels:	
Total topped/rescanned pixels:	
Minimum pixel ceiling(frame):	
Maximum pixel ceiling(frame):	
Total spots predicted:	
Spots with absolute HKL > 511:	
Spots outside resolution limit:	
Spots outside active detector area:	
Outside frame limits:	
Spots exceeding frame queue size:	
Collisions(same XY, adjacent frame):	
Spots exceeding dynamic range:	
Spots with too many spot components:	
Spots with large Lorentz factor:	
Spots with too much missing I:	
Spots with too few BG pixels:	
Spots below I/sigma threshold:	
Spots left in Write-Behind Cache:	
Spots with unwanted components:	
Total unwanted components:	
Good spots written:	
Total spot components written:	
Twin overlaps integrated:	
Partial, strong, full overlaps:	
Full overlaps collapsed to singlet:	
Singlets (used in stats below):	
Twin overlaps written:	
Average Intensity:	
Average I/sigma:	
% over "strong" threshold:	
% less than 2 sigma:	
% which spanned more than 1 frame:	

762	
6071	
163809	
163809	
27750	
0*	
0*	
5200*	
769*	
32*	
0*	
656*	
0*	
2*	
0*	
0*	
77*	
0*	
0*	
0*	
20742	
20742	
0	
20742	
0	
316182.5	
62.669	
74.51	
9.42	
38.08	

- Spots too close to restricted areas (beamstop, ...)
- Spots incomplete due to beginning / end of run
- Spots exceeding frame queue
- Overlapped spots
- Overflowed reflections (detector saturation)

Optimizing Data Integration

- Recycle the orientation matrix
 - Import the *m.p4p and repeat the integration
- Carefully look at the correlation coefficient
- Adjust the resolution limit for the data integration to the diffraction limit of the crystal
- Try to activate "blend profiles" for very weak data
- Increase the box size
- Try fixing the box size
- Increase "queue half width" slightly

SAINT – Output

- Log and statistics
 - Listing files: *.ls
 - Parameter files: *.p4p
- Intensity files:
 - single crystal: *.raw
 - twin: *.mul
 - Modulated *.ram
- Diagnostic output frame files
 - initial background: *.ib
 - active pixel mask: *.am,
 - background snapshots: bg_snap*.sfrm



DATA COLLECTION AND REDUCTION WITH APEX6

Scaling in APEX6

Ashley (Weiland) Schmidt

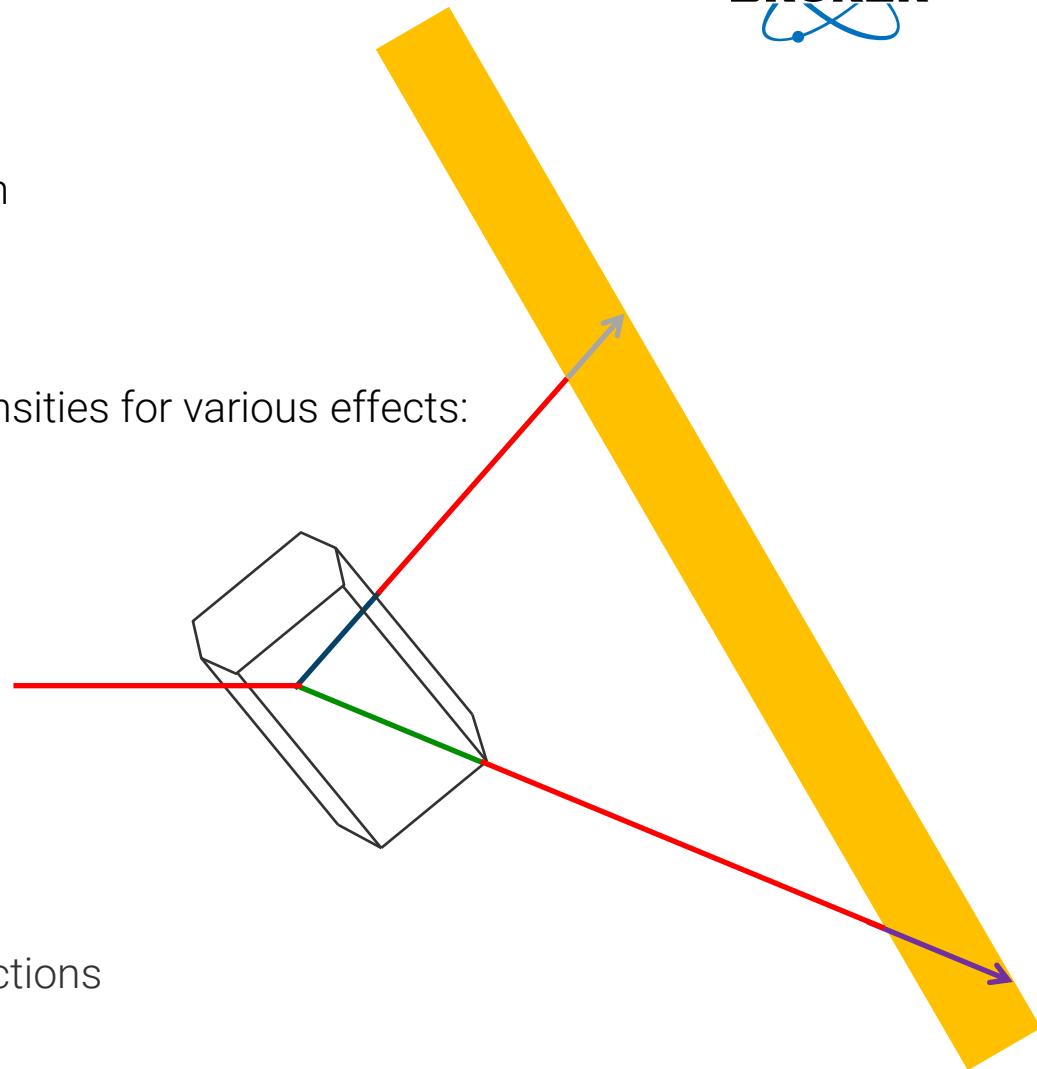
Ashley.Schmidt@bruker.com

SADABS - Data scaling

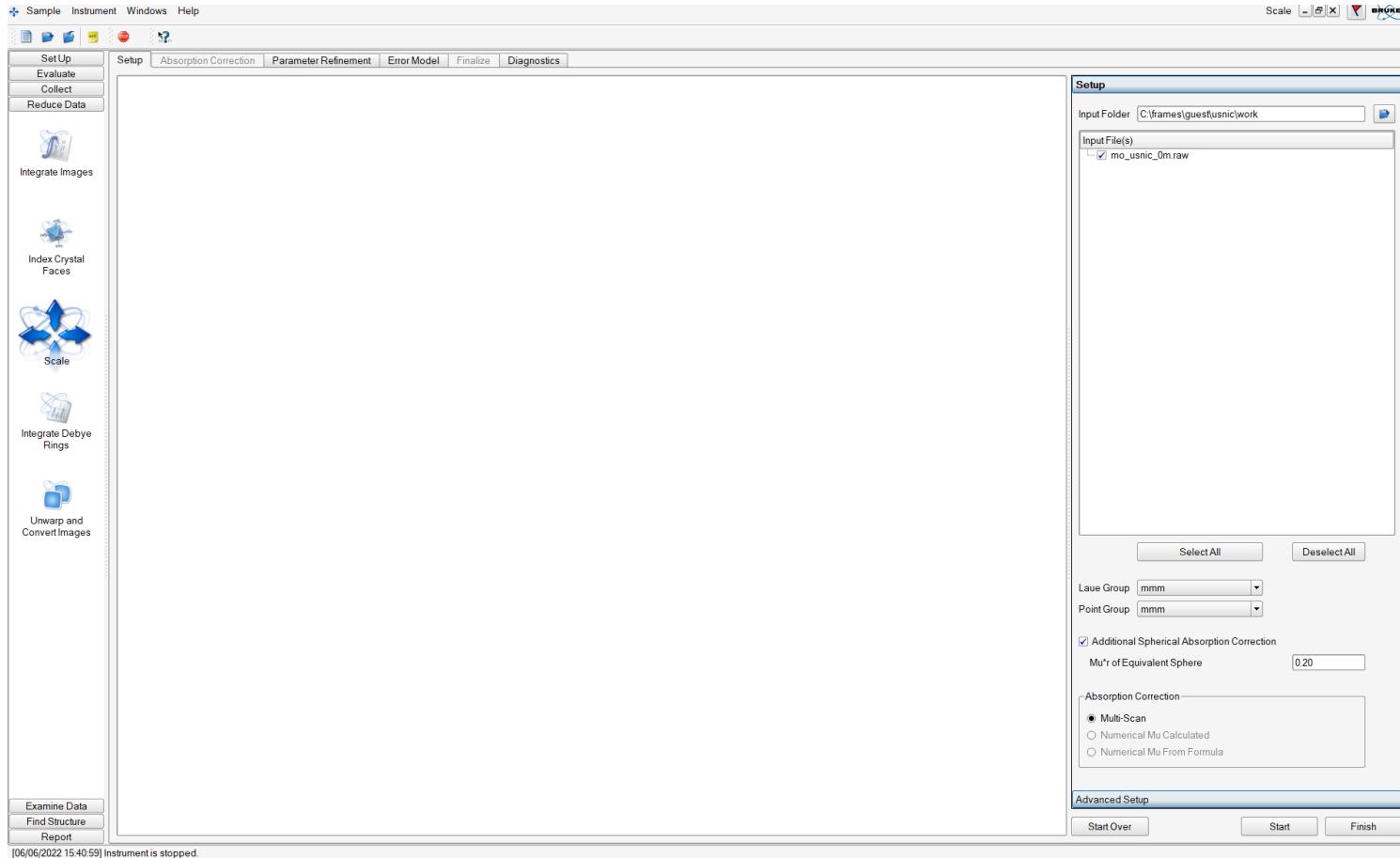
- Data set consists of multiple observations for each unique Bragg reflection
 - Duplicate observations collected at different crystal orientations
 - Symmetry-related reflections
- SADABS exploits multiplicity of observations for correcting integrated intensities for various effects:
 - Absorption due to different path length through crystal
 - Different incident angle on detector
 - Change of irradiated volume
 - Inhomogeneity of the incident beam
 - Crystal miscentering, crystal decay,...

To do so

1. Determination of the measured intensity I_{obs} of a set of equivalent reflections
2. Determination of their standard uncertainties
3. Put data set on a common scale
4. Remove outliers



SCALING

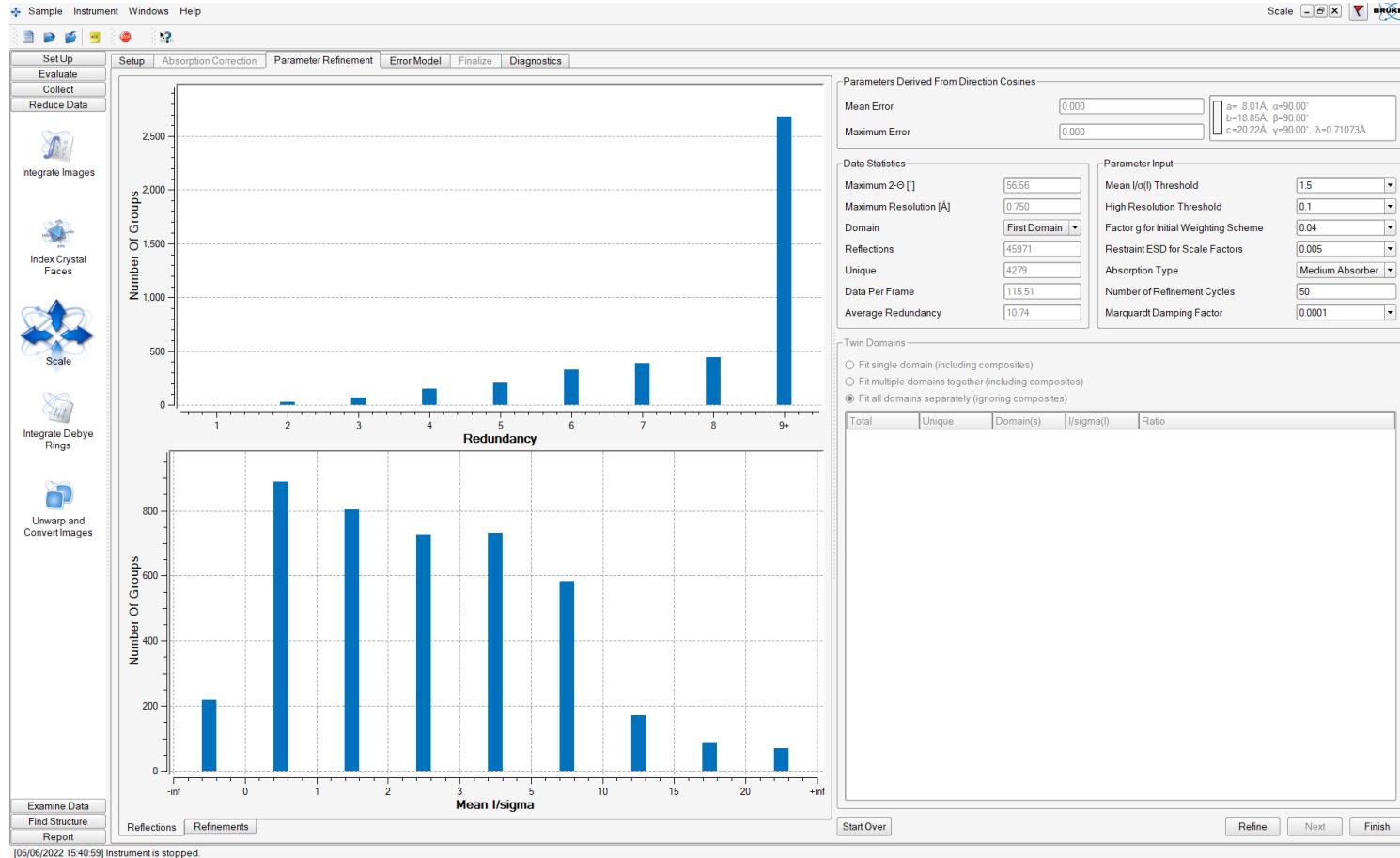


- APEX6 pre-fills important information
 - Input files
 - Output files
 - Symmetry
- Choose combined output from SAINT (default) or individual files
- Adjust $\mu \times r$ if needed
- Numerical absorption correction is an option too

Laue Groups and Point Groups

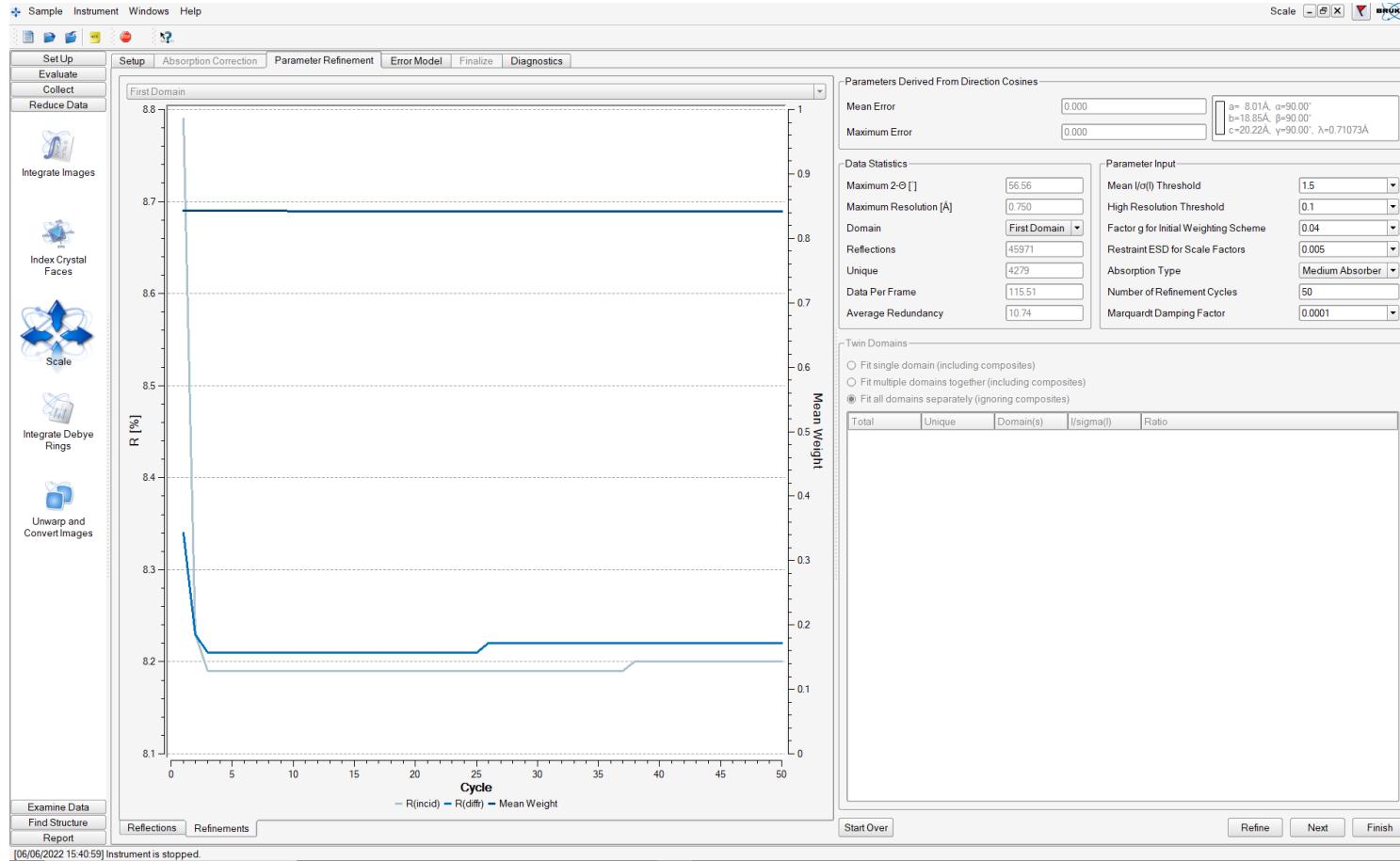
Crystal System	Laue Group	Point Group
Triclinic	-1	1, -1,
Monoclinic	2/m	2, m, 2/m
Orthorhombic	mmm	222, mm2, mmm
Tetragonal	4/m	4, -4, 4/m
	4/mmm	422, 4mm, -42m, 4/mmm
Trigonal	-3	3, -3
	-3m	32, 3m, -3m
Hexagonal	6/m	6, -6, 6/m
	6/mmm	622, 6mm, -62m, 6/mmm
Cubic	m-3	23, m-3
	m-3m	432, -43m, m-3m

SCALING – Parameter Refinement



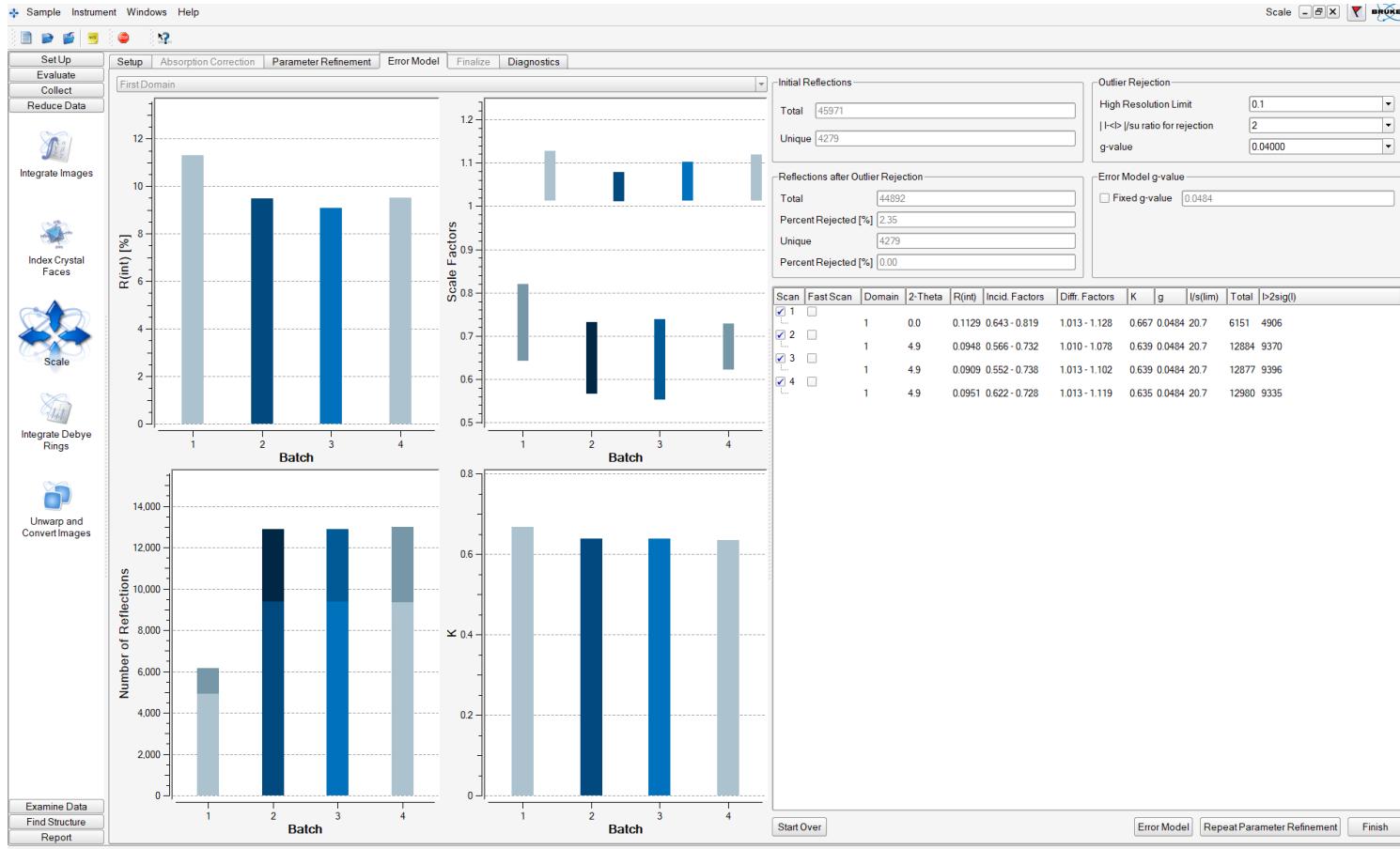
- Parameter input for scaling parameter and absorption correction parameter refinement
- Absorption type
- Restraint esd for scale parameter
 - Increasing allows a faster frame to frame change of scale parameters

SCALING – Parameter Refinement



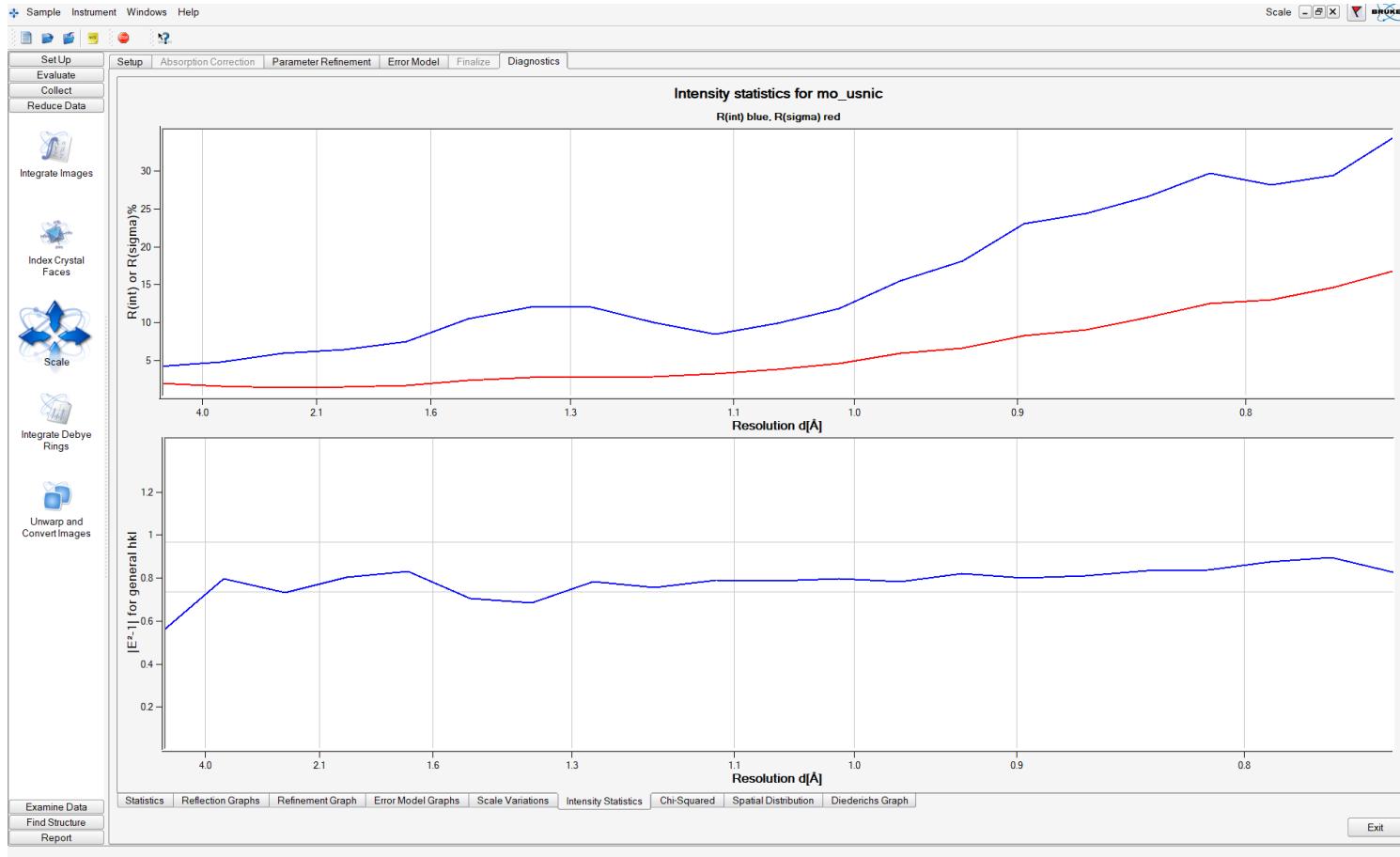
- Run at least 50 cycles
- Mean weight should be above 75%
 - If it is around 60% the chosen symmetry is probably too high
- R values need to converge
 - If you see “ringing” increase the restraint esd for scale parameters

SCALING – Error Model



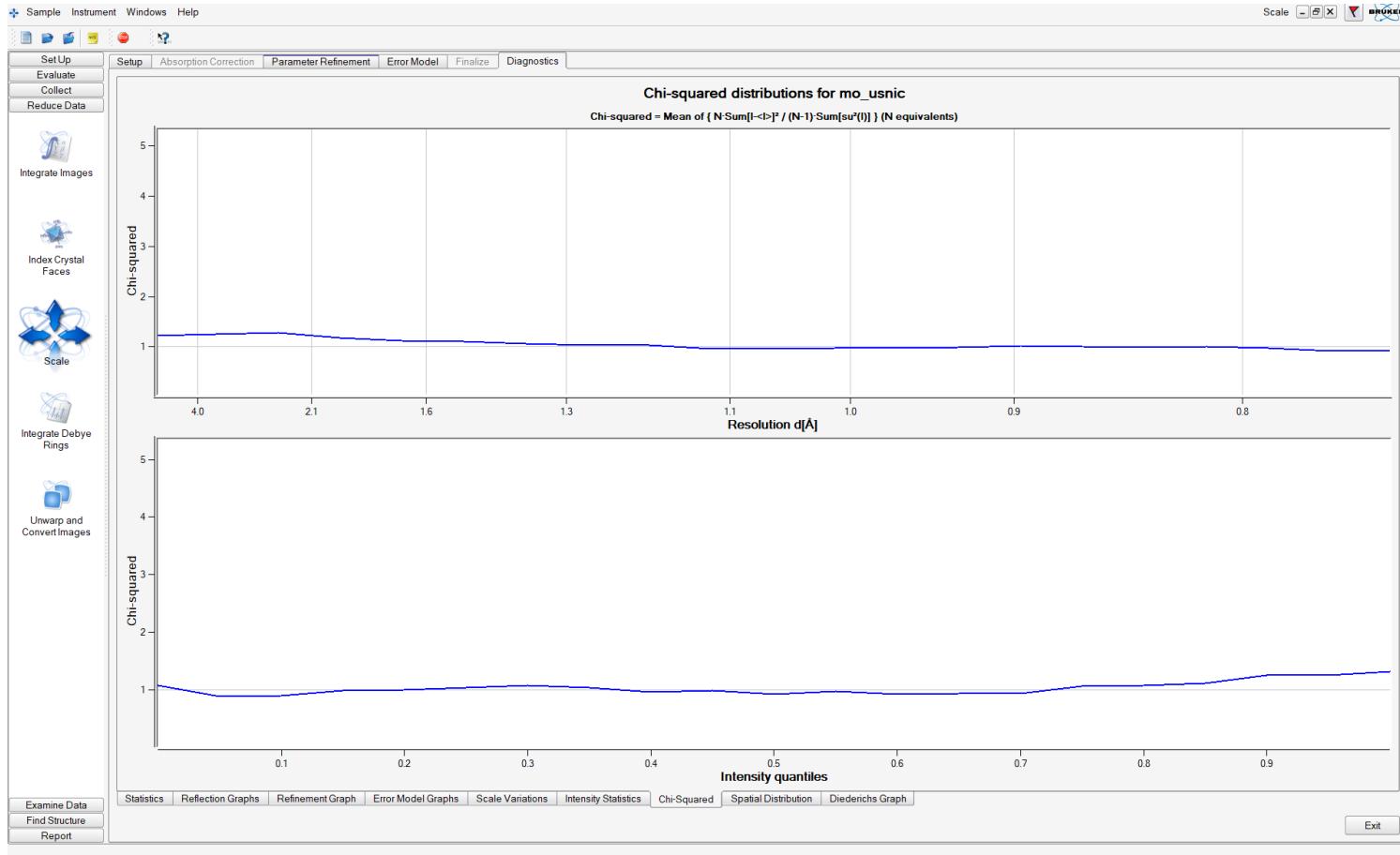
- g-value should be small
 - 0.02 to 0.04
- Only a very small number of reflections should be rejected
- Look for consistency
- If a run sticks out, remove it and start over
 - Provided you have enough redundancy

SCALING – Diagnostic Plots



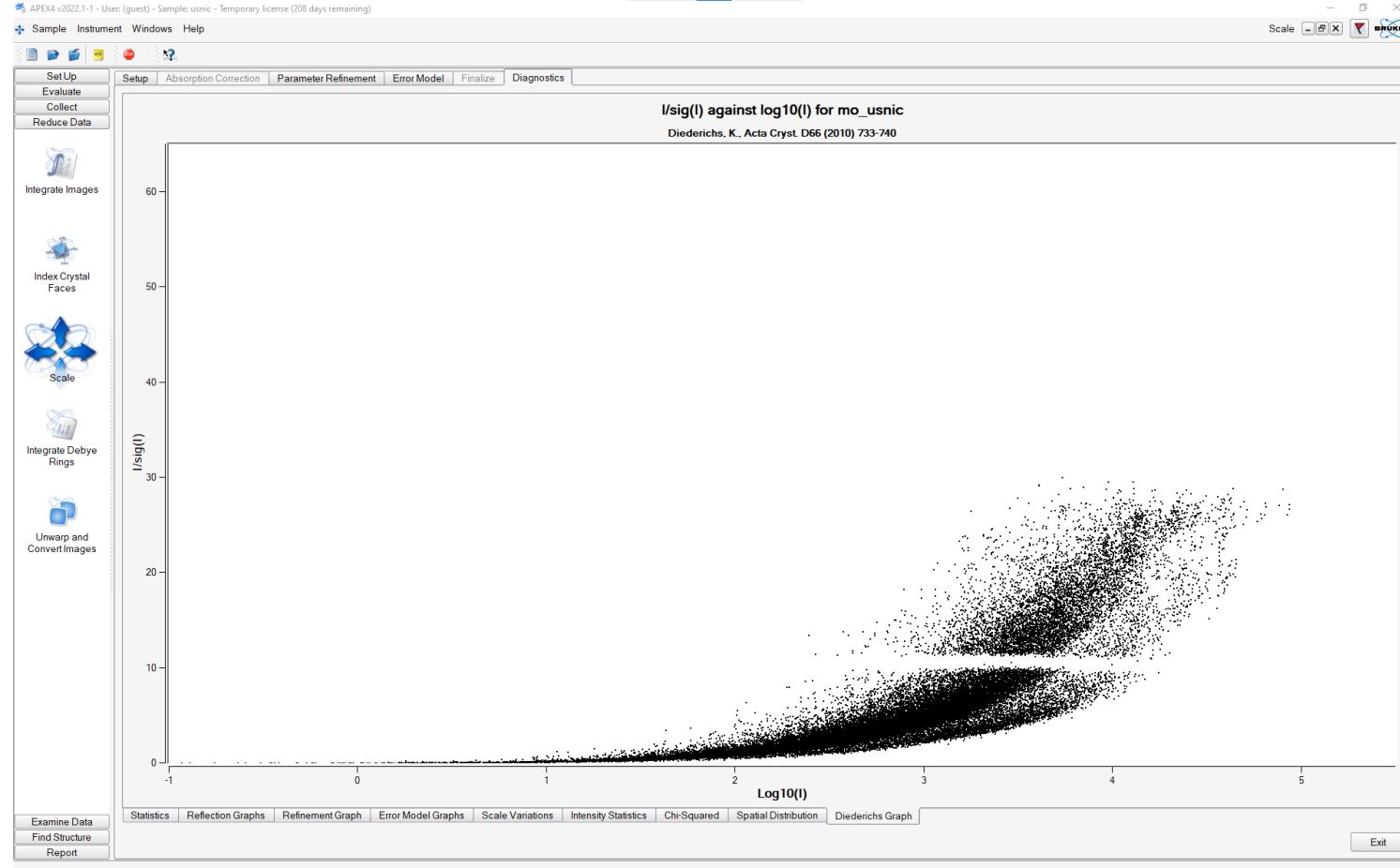
- Rint and Rsigma plot
- For a routine experiment we consider data up to Rsigma of 30% usable

SCALING – Diagnostic Plots



- The chi-squared distribution tells you how “gaussian” the distribution of your ESDs is vs intensities

SCALING – Diagnostic Plots



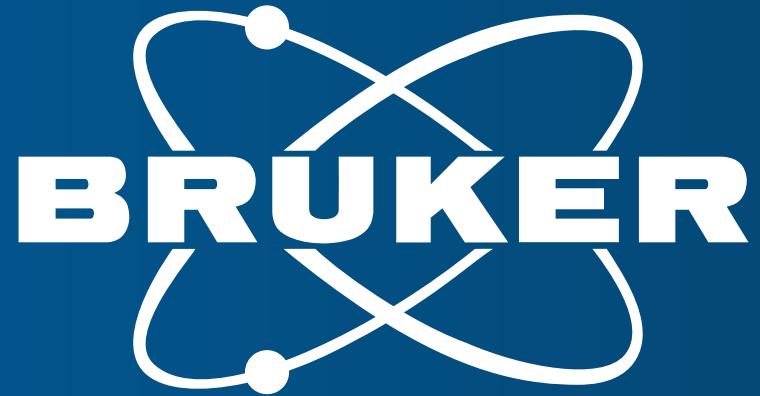
- Diederichs plot
- $I/\text{sig}(I)$ vs $\log I$
- Needs to be an S shaped distribution
- Look for a mean and lean cobra!
- The earlier the cobra rises out of the dust, the better!
- If it is lean, the $R\sigma$ is low
- If it stands up high the error model g value is low



Thank you!

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Innovation with Integrity